
PART NUMBER**5447BEA-ROCV**

**Rochester Electronics
Manufactured Components**

Rochester branded components are manufactured using either die/wafers purchased from the original suppliers or Rochester wafers recreated from the original IP. All re-creations are done with the approval of the Original Component Manufacturer. (OCM)

Parts are tested using original factory test programs or Rochester developed test solutions to guarantee product meets or exceeds the OCM data sheet.

Quality Overview

- ISO-9001
- AS9120 certification
- Qualified Manufacturers List (QML) MIL-PRF-38535
 - Class Q Military
 - Class V Space Level

Qualified Suppliers List of Distributors (QSLD)

- Rochester is a critical supplier to DLA and meets all industry and DLA standards.

Rochester Electronics, LLC is committed to supplying products that satisfy customer expectations for quality and are equal to those originally supplied by industry manufacturers.

The original manufacturer's datasheet accompanying this document reflects the performance and specifications of the Rochester manufactured version of this device. Rochester Electronics guarantees the performance of its semiconductor products to the original OCM specifications. 'Typical' values are for reference purposes only. Certain minimum or maximum ratings may be based on product characterization, design, simulation, or sample testing.

INCH-POUND

MIL-M-38510/10D
16 February 2005
SUPERSEDING
MIL-M-38510/10C
3 March 1986

MILITARY SPECIFICATION

MICROCIRCUITS, DIGITAL, BIPOLAR, TTL, DECODERS MONOLITHIC SILICON

Inactive for new design after 7 September 1995.

This specification is approved for use by all Departments
and Agencies of the Department of Defense.

The requirements for acquiring the product herein shall consist of this specification sheet and MIL-PRF 38535

1. SCOPE

1.1 Scope. This specification covers the detail requirements for monolithic silicon, TTL, microcircuit decoders. Two product assurance classes and a choice of case outlines and lead finishes are provided for each type and are reflected in the complete part number. For this product, the requirements of MIL-M-38510 have been superseded by MIL-PRF-38535, (see 6.4).

1.2 Part or Identifying Number (PIN). The PIN is in accordance with MIL-PRF-38535.

1.2.1 Device types. The device types are as follows:

<u>Device type</u>	<u>Circuit</u>
01	BCD-to-decimal decoder
02	Excess-3-to-decimal decoder
03	Excess-3-gray-to-decimal decoder
04	BCD-to-decimal decoder/driver (30 volt, open collector output)
05	BCD-to-decimal decoder/driver (15 volt, open collector output)
06	BCD-to-seven segment decoder/driver (30 volt, open collector output)
07	BCD-to-seven segment decoder/driver (15 volt, open collector output)
08	BCD-to-seven segment decoder/driver
09	BCD-to-seven segment decoder/driver (5.5 volt, open collector output)

1.2.2 Device class. The device class is the product assurance level as defined in MIL-PRF-38535.

1.2.3 Case outlines. The case outlines are as designated in MIL-STD-1835 and as follows:

<u>Outline letter</u>	<u>Descriptive designator</u>	<u>Terminals</u>	<u>Package style</u>
A	GDFP5-F14 or CDFP6-F14	14	Flat pack
B	GDFP4-F14	14	Flat pack
C	GDIP1-T14 or CDIP2-T14	14	Dual-in-line
D	GDFP1-F14 or CDFP2-F14	14	Flat pack
E	GDIP1-T16 or CDIP2-T16	16	Dual-in-line
F	GDFP2-F16 or CDFP3-F16	16	Flat pack

Comments, suggestions, or questions on this document should be addressed to: Commander, Defense Supply Center Columbus, ATTN: DSCC-VAS, P. O. Box 3990, Columbus, OH 43218-3990, or emailed to bipolar@dsccl.dla.mil. Since contact information can change, you may want to verify the currency of this address information using the ASSIST Online database at <http://assist.daps.dla.mil>.

1.3 Absolute maximum ratings.

Supply voltage range	-0.5 V dc to +7.0 V dc
Input voltage range	-1.5 V dc at -12 mA to +5.5 V dc
Storage temperature range	-65° to +150°C
Maximum power dissipation (P_D): <u>1/</u>	
Device types 01, 02 and 03	226 mW
Device types 04 and 05	341 mW
Device types 06, 07, 08 and 09	467 mW
Lead temperature (soldering, 10 seconds)	+300°C
Thermal resistance, junction to case (θ_{JC}):	
Cases A, B, C, D, E and F	(See MIL-STD-1835)
Junction temperature (T_J) <u>2/</u>	175°C
Maximum current into any output (output off):	
Device types 04, 05, 06, 07 and 09	1 mA

1.4 Recommended operating conditions.

Supply voltage (V_{CC})	4.5 V dc minimum to 5.5 V dc maximum
Minimum high level input voltage (V_{IH})	2.0 V dc
Maximum low level input voltage (V_{IL})	0.8 V dc
Sink current capability by device type:	
Device types 01, 02, 03	16 mA
Device types 04, 05	20 mA
Device types 06, 07	
Outputs A - G	40 mA
BI/RBO node	8 mA
Device type 08	
Outputs A - G	6.4 mA
BI/RBO node	8 mA
Device type 09	10 mA
Case operating temperature range (T_C)	-55° to +125°C

2. APPLICABLE DOCUMENTS

2.1 General. The documents listed in this section are specified in sections 3, 4, or 5 of this specification. This section does not include documents cited in other sections of this specification or recommended for additional information or as examples. While every effort has been made to ensure the completeness of this list, document users are cautioned that they must meet all specified requirements of documents cited in sections 3, 4, or 5 of this specification, whether or not they are listed.

1/ Must withstand the added P_D due to short-circuit test (e.g., I_{OS}).

2/ Maximum junction temperature should not be exceeded except in accordance with allowable short duration burn-in screening condition in accordance with MIL-PRF-38535.

2.2 Government documents.

2.2.1 Specifications and standards. The following specifications and standards form a part of this specification to the extent specified herein. Unless otherwise specified, the issues of these documents are those cited in the solicitation or contract.

DEPARTMENT OF DEFENSE SPECIFICATIONS

MIL-PRF-38535 - Integrated Circuits (Microcircuits) Manufacturing, General Specification for.

DEPARTMENT OF DEFENSE STANDARDS

MIL-STD-883 - Test Method Standard for Microelectronics.
MIL-STD-1835 - Interface Standard Electronic Component Case Outlines

(Copies of these documents are available online at <http://assist.daps.dla.mil/quicksearch/> or <http://assist.daps.dla.mil> or from the Standardization Document Order Desk, 700 Robbins Avenue, Building 4D, Philadelphia, PA 19111-5094.)

2.3 Order of precedence. In the event of a conflict between the text of this specification and the references cited herein, the text of this document takes precedence. Nothing in this document, however, supersedes applicable laws and regulations unless a specific exemption has been obtained.

3. REQUIREMENTS

3.1 Qualification. Microcircuits furnished under this specification shall be products that are manufactured by a manufacturer authorized by the qualifying activity for listing on the applicable qualified manufacturers list before contract award (see 4.3 and 6.3).

3.2 Item requirements. The individual item requirements shall be in accordance with MIL-PRF-38535 and as specified herein or as modified in the device manufacturer's Quality Management (QM) plan. The modification in the QM plan shall not affect the form, fit, or function as described herein. This slash sheet has been modified to allow the manufacturer to use the alternate die/fabrication requirements of paragraph A.3.2.2 of MIL-PRF-38535 or other alternative approved by the qualifying activity.

3.3 Design, construction, and physical dimensions. The design, construction, and physical dimensions shall be as specified in MIL-PRF-38535 and herein.

3.3.1 Case outlines. The case outlines shall be as specified in 1.2.3.

3.3.2 Logic diagrams and terminal connections. The logic diagrams and terminal connections shall be as specified on figures 1 and 2.

3.3.3 Truth tables. The truth tables shall be as specified on figure 3.

3.3.4 Schematic circuits. The schematic circuits shall be maintained by the manufacturer and made available to the qualifying activity and the preparing activity upon request.

3.4 Lead material and finish. The lead material and finish shall be in accordance with MIL-PRF-38535 (see 6.6).

3.5 Electrical performance characteristics. The electrical performance characteristics are as specified in table I, and apply over the full recommended case operating temperature range, unless otherwise specified.

3.6 Electrical test requirements. The electrical test requirements for each device class shall be the subgroups specified in table II. The electrical tests for each subgroup are described in table III.

MIL-M-38510/10D

TABLE I. Electrical performance characteristics, device types 01, 02 and 03.

Test	Symbol	Conditions -55°C ≤ T _C ≤ +125°C unless otherwise specified	Limits		Unit
			Min	Max	
High level output voltage	V _{OH}	V _{CC} = 4.5 V, I _{OH} = -0.8 mA	2.4		V
Low level output voltage	V _{OL}	V _{CC} = 4.5 V, I _{OL} = 16 mA, V _{IN} = 0.8 V and 2.0 V		0.4	V
Input clamp voltage	V _{IC}	V _{CC} = 4.5 V, I _{IN} = -12 mA		-1.5	V
Low level input current	I _{IL}	V _{CC} = 5.5 V, V _{IN} = 0.4 V <u>1/</u>	-0.7	-1.6	mA
High level input current	I _{IH1}	V _{CC} = 5.5 V, V _{IN} = 2.4 V <u>2/</u>		40	μA
	I _{IH2}	V _{CC} = 5.5 V, V _{IN} = 5.5 V <u>2/</u>		100	μA
Short circuit output current	I _{OS}	V _{CC} = 5.5 V <u>3/</u>	-20	-55	mA
Supply current	I _{CC}	V _{CC} = 5.5 V, V _{IN} = 0 V		41	mA
Propagation delay time through two logic levels	t _{PHL}	C _L = 50 pF minimum, R _L = 390 Ω ±5% (Figure 4)	5	39	ns
Propagation delay time through two logic levels	t _{PLH}		5	39	ns
Propagation delay time through three logic levels	t _{PHL}		5	46	ns
Propagation delay time through three logic levels	t _{PLH}		5	46	ns

1/ All unspecified inputs at 5.5 volts.

2/ All unspecified inputs grounded.

3/ Not more than one output should be shorted at one time.

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TABLE I. Electrical performance characteristics, device types 04 and 05.

Test	Symbol	Conditions -55°C ≤ T _C ≤ +125°C unless otherwise specified	Limits		Unit
			Min	Max	
Low level output voltage	V _{OL1}	V _{CC} = 4.5 V, I _{OL} = 80 mA		0.9	V
Low level output voltage	V _{OL2}	V _{CC} = 4.5 V, I _{OL} = 20 mA		0.4	V
Input clamp voltage	V _{IC}	V _{CC} = 4.5 V, I _{IN} = -12 mA		-1.5	V
Maximum collector cut-off current	I _{CEX}	V _{CC} = 4.5 V, V _{OH} = max <u>1/</u>		250	μA
Low level input current	I _{IL}	V _{CC} = 5.5 V, V _{IN} = 0.4 V <u>2/</u>	-0.7	-1.6	mA
High level input current	I _{IH1}	V _{CC} = 5.5 V, V _{IN} = 2.4 V <u>3/</u>		40	μA
	I _{IH2}	V _{CC} = 5.5 V, V _{IN} = 5.5 V <u>3/</u>		100	μA
Supply current	I _{CC}	V _{CC} = 5.5 V, V _{IN} = 0 V		62	mA
Propagation delay time to a high logic level	t _{PLH}	C _L = 50 pF minimum, R _L = 390 Ω ±5% (Figure 5)	5	73	ns
Propagation delay time to a low logic level	t _{PHL}		5	73	ns

1/ Device type 04 maximum V_{OH} = 30 V.
Device type 05 maximum V_{OH} = 15 V.

2/ All unspecified inputs at 5.5 volts.

3/ All unspecified inputs grounded.

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TABLE I. Electrical performance characteristics, device types 06 and 07.

Test	Symbol	Conditions -55°C ≤ T _C ≤ +125°C unless otherwise specified	Limits		Unit
			Min	Max	
Low level output voltage <u>1/</u>	V _{OL1}	V _{CC} = 4.5 V, I _{OL} = 40 mA		0.4	V
Low level output voltage <u>2/</u>	V _{OL2}	V _{CC} = 4.5 V, I _{OL} = 8 mA		0.4	V
Input clamp voltage	V _{IC}	V _{CC} = 4.5 V, I _{IN} = -12 mA		-1.5	V
High level output voltage <u>2/</u>	V _{OH}	V _{CC} = 4.5 V, I _{OH} = -0.2 mA	2.4		V
Maximum collector cut-off current <u>3/</u>	I _{CEX}	V _{CC} = 4.5 V, V _{OH} = max <u>3/</u>		250	μA
Low level input current <u>4/</u>	I _{IL1}	V _{CC} = 5.5 V, V _{IN} = 0.4 V <u>5/</u>	-0.4	-1.6	mA
Low level input current <u>2/</u>	I _{IL2}	V _{CC} = 5.5 V, V _{IN} = 0.4 V <u>5/</u>	-1.7	-4.2	mA
High level input current <u>4/</u>	I _{IH1}	V _{CC} = 5.5 V, V _{IN} = 2.4 V <u>6/</u>		40	μA
	I _{IH2}	V _{CC} = 5.5 V, V _{IN} = 5.5 V <u>6/</u>		100	μA
Short circuit output current <u>1/</u>	I _{OS}	V _{CC} = 5.5 V <u>6/</u>		-4	mA
Supply current	I _{CC}	V _{CC} = 5.5 V, V _{IN} = 5.5 V		85	mA
Propagation delay time from any input except RBI to any output	t _{PLH}	C _L = 50 pF minimum, R _L = 120 Ω ±5% <u>1/</u> R _L = 560 Ω ±5% <u>2/</u> (Figure 6)	8	144	ns
Propagation delay time from RBI to any output	t _{PLH}		8	144	ns
Propagation delay time from any input except RBI to any output	t _{PHL}		8	144	ns
Propagation delay time from RBI to any output	t _{PHL}		8	144	ns

1/ Outputs A through G only.

2/ BI/RBO node only.

3/ Device type 06 maximum V_{OH} = 30 V.
Device type 07 maximum V_{OH} = 15 V.

4/ Any input except BI/RBO node.

5/ All unspecified inputs at 5.5 volts.

6/ All unspecified inputs grounded.

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TABLE I. Electrical performance characteristics, device types 08.

Test	Symbol	Conditions -55°C ≤ T _C ≤ +125°C unless otherwise specified	Limits		Unit
			Min	Max	
High level output voltage <u>1/</u>	V _{OH1}	V _{CC} = 4.5 V, I _{OH} = -0.4 mA	2.4		V
High level output voltage <u>2/</u>	V _{OH2}	V _{CC} = 4.5 V, I _{OH} = -0.2 mA	2.4		V
Low level output voltage <u>1/</u>	V _{OL1}	V _{CC} = 4.5 V, I _{OL} = 6.4 mA		0.4	V
Low level output voltage <u>2/</u>	V _{OL2}	V _{CC} = 4.5 V, I _{OL} = 8 mA		0.4	V
Input clamp voltage	V _{IC}	V _{CC} = 4.5 V, I _{IN} = -12 mA		-1.5	V
Low level input current <u>3/</u>	I _{IL1}	V _{CC} = 5.5 V, V _{IN} = 0.4 V <u>4/</u>	-0.4	-1.6	mA
Low level input current <u>3/</u>	I _{IL2}	V _{CC} = 5.5 V, V _{IN} = 0.4 V <u>4/</u>	-1.7	-4.2	mA
High level input current <u>3/</u>	I _{IH1}	V _{CC} = 5.5 V, V _{IN} = 2.4 V <u>5/</u>		40	μA
	I _{IH2}	V _{CC} = 5.5 V, V _{IN} = 5.5 V <u>5/</u>		100	μA
Short circuit output current	I _{OS}	V _{CC} = 5.5 V		-4	mA
Supply current	I _{CC}	V _{CC} = 5.5 V, V _{IN} = 0 V		76	mA
Propagation delay time from any input except RBI to any output	t _{PLH}	C _L = 50 pF minimum, R _L = 750 Ω ±5% <u>1/</u> R _L = 560 Ω ±5% <u>2/</u> (Figure 7)	8	144	ns
Propagation delay time from RBI to any output	t _{PLH}		8	144	ns
Propagation delay time from any input except RBI to any output	t _{PHL}		8	144	ns
Propagation delay time from RBI to any output	t _{PHL}		8	144	ns

1/ Outputs A through G only.

2/ BI/RBO node only.

3/ Any input except BI/RBO node.

4/ All unspecified inputs at 5.5 volts.

5/ All unspecified inputs grounded.

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TABLE I. Electrical performance characteristics, device types 09.

Test	Symbol	Conditions -55°C ≤ T _C ≤ +125°C unless otherwise specified	Limits		Unit
			Min	Max	
Low level output voltage	V _{OL}	V _{CC} = 4.5 V, I _{OL} = 10 mA		0.4	V
Input clamp voltage	V _{IC}	V _{CC} = 4.5 V, I _{IN} = -12 mA		-1.5	V
Maximum collector cut-off current	I _{CEX}	V _{CC} = 4.5 V, V _{OH} = 5.5 V		250	μA
Low level input current	I _{IL}	V _{CC} = 5.5 V, V _{IN} = 0.4 V <u>1/</u>	-0.4	-1.6	mA
High level input current	I _{IH1}	V _{CC} = 5.5 V, V _{IN} = 2.4 V <u>2/</u>		40	μA
	I _{IH2}	V _{CC} = 5.5 V, V _{IN} = 5.5 V <u>2/</u>		100	μA
Supply current	I _{CC}	V _{CC} = 5.5 V, V _{IN} = 0 V		47	mA
Propagation delay time from any input to any output	t _{PLH}	C _L = 50 pF minimum, R _L = 470 Ω ±5% (Figure 8)	8	144	ns
Propagation delay time from any input to any output	t _{PHL}		8	144	ns

1/ All unspecified inputs at 5.5 volts.

2/ All unspecified inputs grounded.

TABLE II. Electrical test requirements.

MIL-PRF-38535 test requirements	Subgroups (see table III)	
	Class S devices	Class B devices
Interim electrical parameters	1	1
Final electrical test parameters	1*, 2, 3, 7 9, 10, 11	1*, 2, 3, 7, 9
Group A test requirements	1, 2, 3, 7, 8 9, 10, 11	1, 2, 3, 7, 8, 9, 10, 11
Group B electrical test parameters when using the method 5005 QCI option	1, 2, 3, 9, 10, 11	N/A
Group C end-point electrical parameters	1, 2, 3, 9, 10, 11	1, 2, 3
Group D end-point electrical parameters	1, 2, 3	1, 2, 3

*PDA applies to subgroup 1.

3.7 Marking. Marking shall be in accordance with MIL-PRF-38535.

3.7.1 Certification/compliance mark. The certification mark for device classes Q and V shall be a "QML" or "Q" as required in MIL-PRF-38535. For class Q product built in accordance with A.3.2.2 of MIL-PRF-38535 or other alternative approved by the qualifying activity, the "QD" certification mark shall be used in place of the "QML" or "Q" certification mark.

3.8 Microcircuit group assignment. The devices covered by this specification shall be in microcircuit group number 4 (see MIL-PRF-38535, appendix A).

4. VERIFICATION

4.1 Sampling and inspection. Sampling and inspection procedures shall be in accordance with MIL-PRF-38535 or as modified in the device manufacturer's Quality Management (QM) plan. The modification in the QM plan shall not effect the form, fit, or function as described herein.

4.2 Screening. Screening shall be in accordance with MIL-PRF-38535 and shall be conducted on all devices prior to qualification and conformance inspection. The following additional criteria shall apply:

- a. The burn-in test duration, test condition, and test temperature, or approved alternatives shall be as specified in the device manufacturer's QM plan in accordance with MIL-PRF-38535. The burn-in test circuit shall be maintained under document control by the device manufacturer's Technology Review Board (TRB) in accordance with MIL-PRF-38535 and shall be made available to the acquiring or preparing activity upon request. The test circuit shall specify the inputs, outputs, biases, and power dissipation, as applicable, in accordance with the intent specified in test method 1015 of MIL-STD-883.
- b. Interim and final electrical test parameters shall be as specified in table II, except interim electrical parameters test prior to burn-in is optional at the discretion of the manufacturer.
- c. Additional screening for space level product shall be as specified in MIL-PRF-38535.

4.3 Qualification inspection. Qualification inspection shall be in accordance with MIL-PRF-38535.

4.4 Technology Conformance Inspection (TCI). Technology conformance inspection shall be in accordance with MIL-PRF-38535 and herein for groups A, B, C, and D inspections (see 4.4.1 through 4.4.4).

4.4.1 Group A inspection. Group A inspection shall be in accordance with table III of MIL-PRF-38535 and as follows:

- a. Tests shall be as specified in table II herein.
- b. Subgroups 4, 5, and 6 shall be omitted.

4.4.2 Group B inspection. Group B inspection shall be in accordance with table II of MIL-PRF-38535.

4.4.3 Group C inspection. Group C inspection shall be in accordance with table IV of MIL-PRF-38535 and as follows:

- a. End-point electrical parameters shall be as specified in table II herein.
- b. The steady-state life test duration, test condition, and test temperature, or approved alternatives shall be as specified in the device manufacturer's QM plan in accordance with MIL-PRF-38535. The burn-in test circuit shall be maintained under document control by the device manufacturer's Technology Review Board (TRB) in accordance with MIL-PRF-38535 and shall be made available to the acquiring or preparing activity upon request. The test circuit shall specify the inputs, outputs, biases, and power dissipation, as applicable, in accordance with the intent specified in test method 1005 of MIL-STD-883.

4.4.4 Group D inspection. Group D inspection shall be in accordance with table V of MIL-PRF-38535. End-point electrical parameters shall be as specified in table II herein.

4.5 Methods of inspection. Methods of inspection shall be specified as follows:

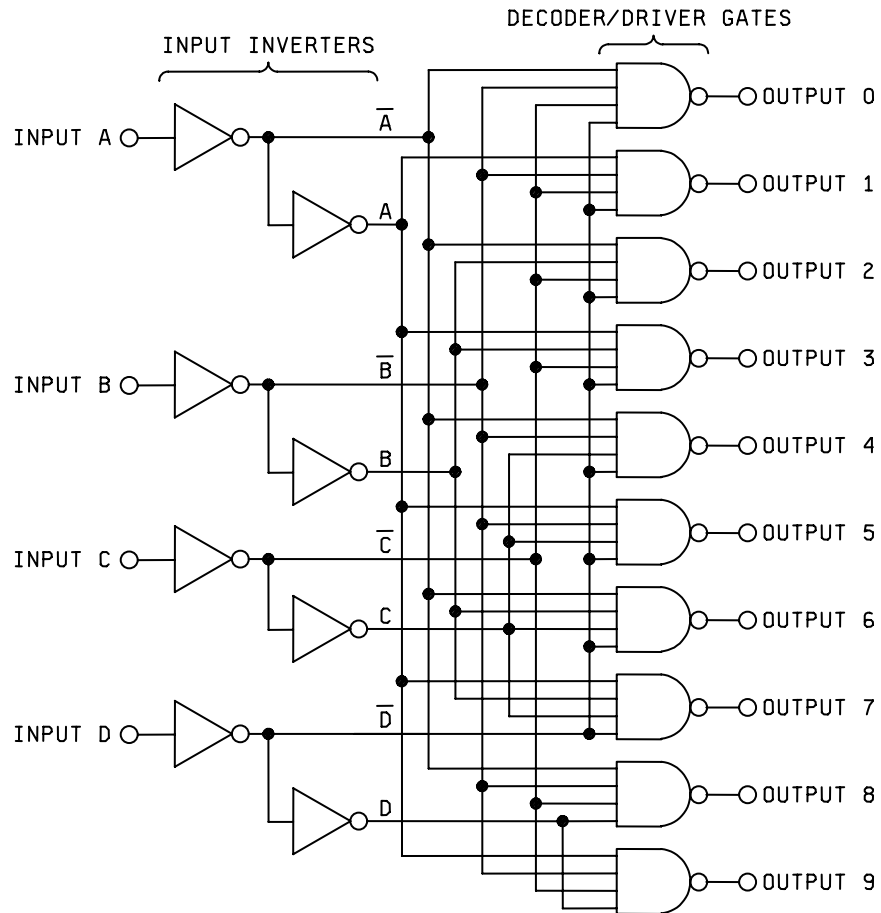
4.5.1 Voltage and current. All voltages given are referenced to the microcircuit ground terminal. Currents given are conventional and positive when flowing into the referenced terminal.

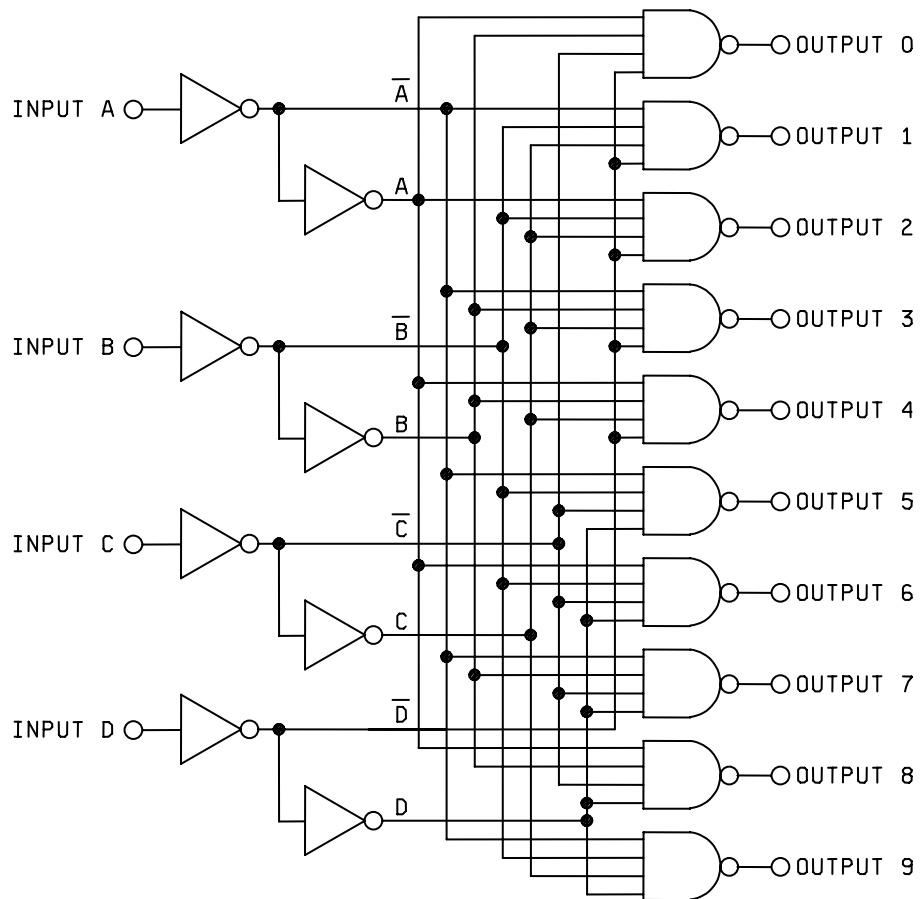
Terminal number	Device type 01, 02, 03, 04, and 05	Device type 06 and 07	Device type 08	Device type 09
	Cases E and F	Cases E and F	Cases E and F	Cases A, B, C, and D
1	OUT 0	IN B	IN B	IN B
2	OUT 1	IN C	IN C	IN C
3	OUT 2	LT	LT	BI
4	OUT 3	RBO	RBO/B1	IN D
5	OUT 4	RBI	RBI	IN A
6	OUT 5	IN D	IN D	OUT E
7	OUT 6	IN A	IN A	GND
8	GND	GND	GND	OUT D
9	OUT 7	OUT E	OUT E	OUT C
10	OUT 8	OUT D	OUT D	OUT B
11	OUT 9	OUT C	OUT C	OUT A
12	IN D	OUT B	OUT B	OUT G
13	IN C	OUT A	OUT A	OUT F
14	IN B	OUT G	OUT G	V _{CC}
15	IN A	OUT F	OUT F	
16	V _{CC}	V _{CC}	V _{CC}	

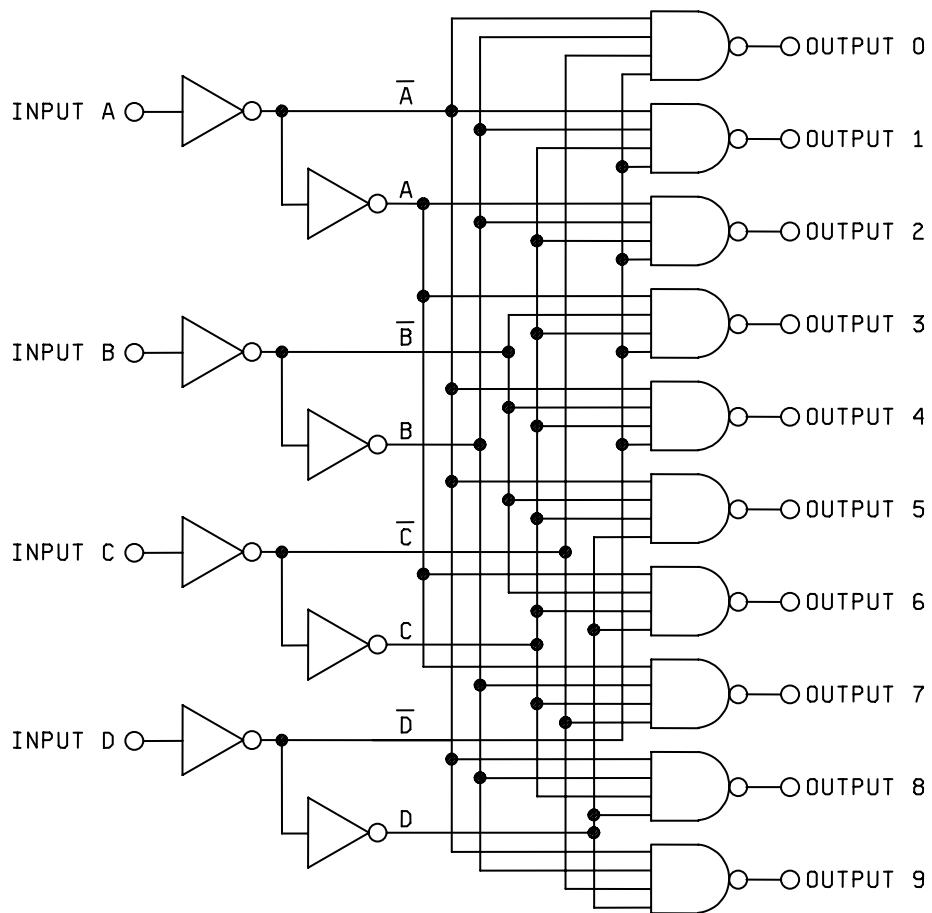
LT = Lamp Test
BI = Blanking Input
RBO = Ripple-blanking Output
RBI = Ripple-blanking Input

FIGURE 1. Terminal connections.

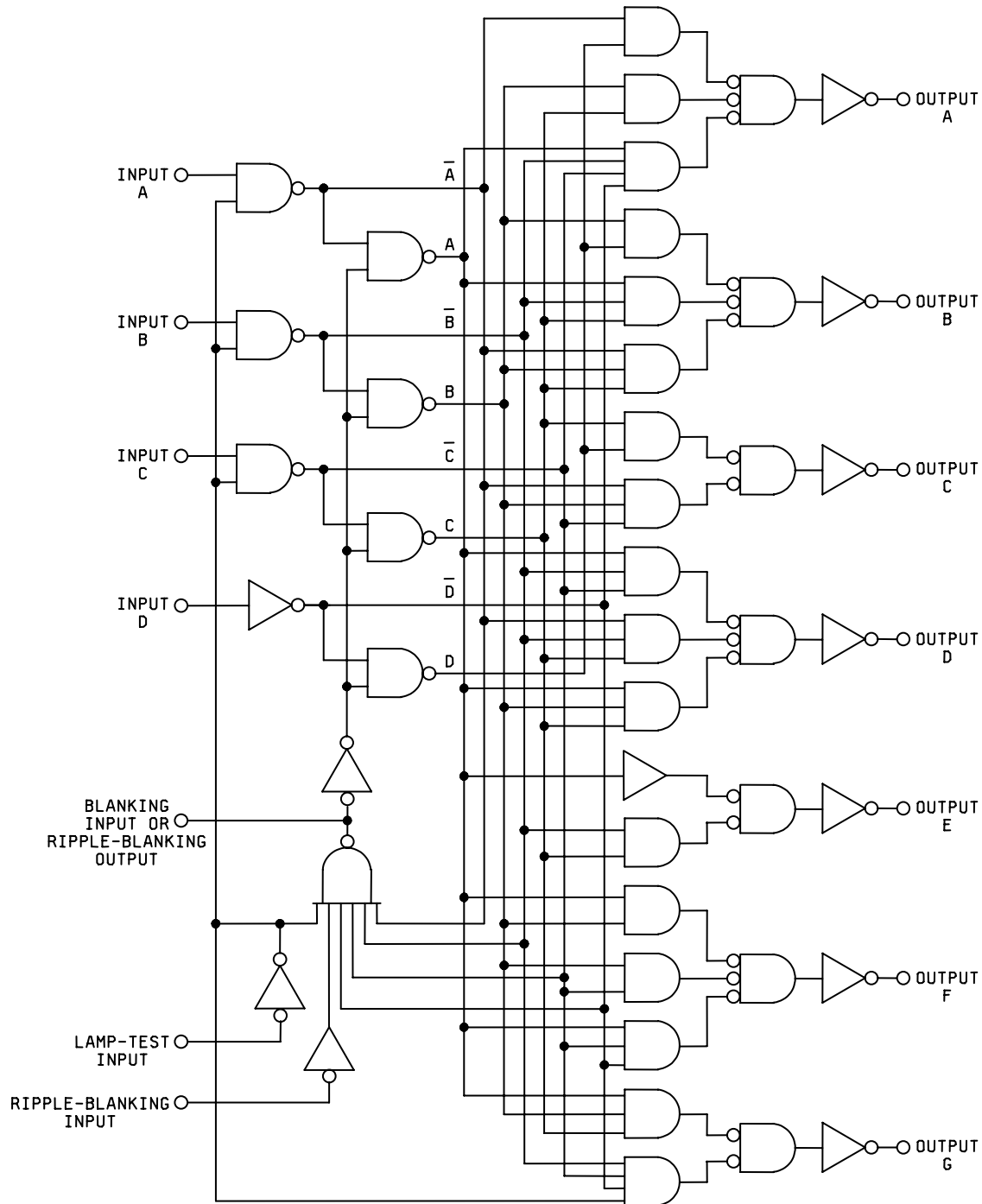
DEVICE TYPE 01,04 AND 05

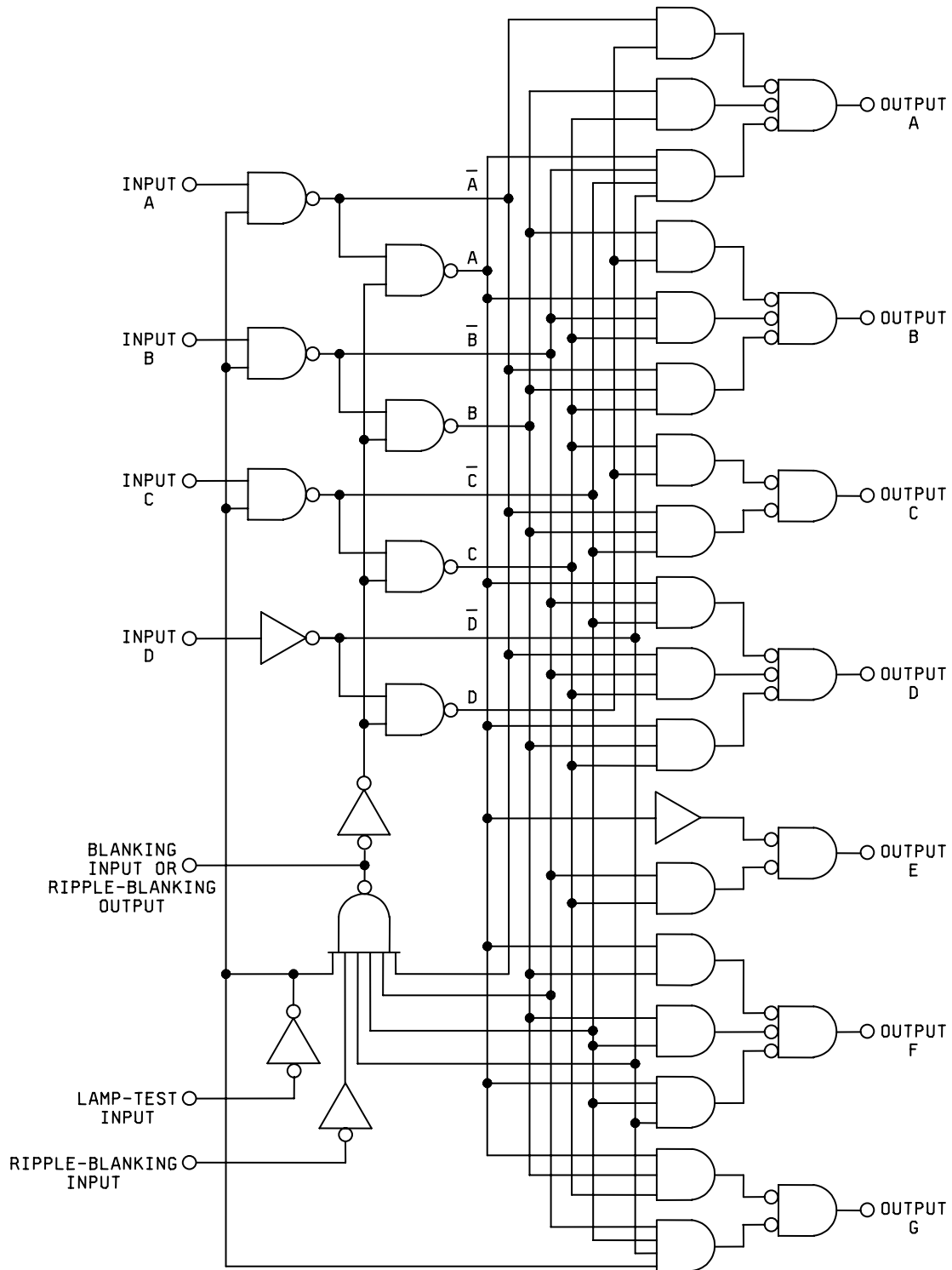
FIGURE 2. Logic diagrams.

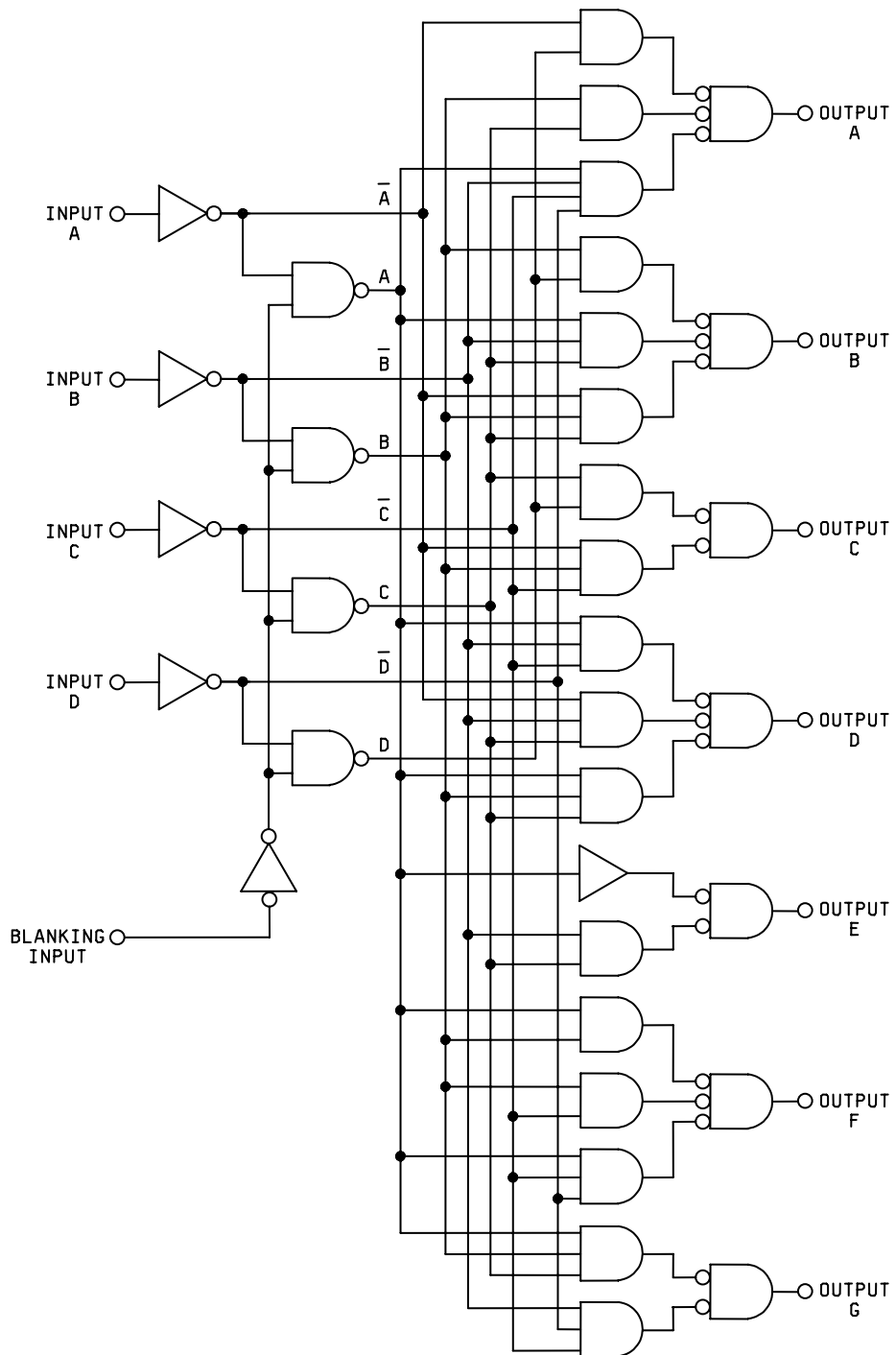
DEVICE TYPE 02FIGURE 2. Logic diagrams - Continued.

DEVICE TYPE 03FIGURE 2. Logic diagrams - Continued.

DEVICE TYPES 06 AND 07

FIGURE 2. Logic diagrams - Continued.

FIGURE 2. Logic diagrams - Continued.

DEVICE TYPE 09FIGURE 2. Logic diagrams - Continued.

Device types 01, 04, and 05

INPUTS				OUTPUTS									
D	C	B	A	0	1	2	3	4	5	6	7	8	9
L	L	L	L	L	H	H	H	H	H	H	H	H	H
L	L	L	H	H	L	H	H	H	H	H	H	H	H
L	L	H	L	H	H	L	H	H	H	H	H	H	H
L	L	H	H	H	H	H	L	H	H	H	H	H	H
L	H	L	L	H	H	H	H	L	H	H	H	H	H
L	H	L	H	H	H	H	H	H	L	H	H	H	H
L	H	H	L	H	H	H	H	H	H	L	H	H	H
L	H	H	H	H	H	H	H	H	H	H	L	H	H
H	L	L	L	H	H	H	H	H	H	H	H	L	H
H	L	L	H	H	H	H	H	H	H	H	H	H	L
H	L	H	L	H	H	H	H	H	H	H	H	H	H
H	L	H	H	H	H	H	H	H	H	H	H	H	H
H	H	L	L	H	H	H	H	H	H	H	H	H	H
H	H	L	H	H	H	H	H	H	H	H	H	H	H
H	H	H	L	H	H	H	H	H	H	H	H	H	H
H	H	H	H	H	H	H	H	H	H	H	H	H	H

FIGURE 3. Truth tables.

Device type 02

INPUTS				OUTPUTS									
D	C	B	A	0	1	2	3	4	5	6	7	8	9
L	L	H	H	L	H	H	H	H	H	H	H	H	H
L	H	L	L	H	L	H	H	H	H	H	H	H	H
L	H	L	H	H	H	L	H	H	H	H	H	H	H
L	H	H	L	H	H	H	L	H	H	H	H	H	H
L	H	H	H	H	H	H	H	L	H	H	H	H	H
H	L	L	L	H	H	H	H	H	L	H	H	H	H
H	L	L	H	H	H	H	H	H	H	L	H	H	H
H	L	H	L	H	H	H	H	H	H	H	L	H	H
H	L	H	H	H	H	H	H	H	H	H	H	L	H
H	H	L	L	H	H	H	H	H	H	H	H	H	L
H	H	L	H	H	H	H	H	H	H	H	H	H	H
H	H	H	L	H	H	H	H	H	H	H	H	H	H
H	H	H	H	H	H	H	H	H	H	H	H	H	H
L	L	L	L	H	H	H	H	H	H	H	H	H	H
L	L	L	H	H	H	H	H	H	H	H	H	H	H
L	L	H	L	H	H	H	H	H	H	H	H	H	H

Device type 03

INPUTS				OUTPUTS									
D	C	B	A	0	1	2	3	4	5	6	7	8	9
L	L	H	L	L	H	H	H	H	H	H	H	H	H
L	H	H	L	H	L	H	H	H	H	H	H	H	H
L	H	H	H	H	H	L	H	H	H	H	H	H	H
L	H	L	H	H	H	H	L	H	H	H	H	H	H
L	H	L	L	H	H	H	H	L	H	H	H	H	H
H	H	L	L	H	H	H	H	H	L	H	H	H	H
H	H	L	H	H	H	H	H	H	H	L	H	H	H
H	H	H	H	H	H	H	H	H	H	H	L	H	H
H	H	H	L	H	H	H	H	H	H	H	H	L	H
H	L	H	L	H	H	H	H	H	H	H	H	H	L
H	L	H	H	H	H	H	H	H	H	H	H	H	H
H	L	L	H	H	H	H	H	H	H	H	H	H	H
H	L	L	L	H	H	H	H	H	H	H	H	H	H
L	L	L	L	H	H	H	H	H	H	H	H	H	H
L	L	L	H	H	H	H	H	H	H	H	H	H	H
L	L	H	H	H	H	H	H	H	H	H	H	H	H

FIGURE 3. Truth tables - Continued.

Device types 06 and 07

DECIMAL OR FUNCTION	INPUTS							OUTPUTS							NOTE
	LT	RBI	D	C	B	A	BI/RBO	A	B	C	D	E	F	G	
0	H	H	L	L	L	L	H	L	L	L	L	L	L	H	1
1	H	X	L	L	L	H	H	H	L	L	H	H	H	H	1
2	H	X	L	L	H	L	H	L	L	H	L	L	H	L	
3	H	X	L	L	H	H	H	L	L	L	L	H	H	L	
4	H	X	L	H	L	L	H	H	L	L	H	H	L	L	
5	H	X	L	H	L	H	H	L	H	L	L	H	L	L	
6	H	X	L	H	H	L	H	H	H	L	L	L	L	L	
7	H	X	L	H	H	H	H	L	L	L	H	H	H	H	
8	H	X	H	L	L	L	H	L	L	L	L	L	L	L	
9	H	X	H	L	L	H	H	L	L	L	H	H	L	L	
10	H	X	H	L	H	L	H	H	H	H	L	L	H	L	
11	H	X	H	L	H	H	H	H	H	L	L	H	H	L	
12	H	X	H	H	L	L	H	H	L	H	H	H	L	L	
13	H	X	H	H	L	H	H	L	H	H	L	H	L	L	
14	H	X	H	H	H	L	H	H	H	H	L	L	L	L	
15	H	X	H	H	H	H	H	H	H	H	H	H	H	H	
BI	X	X	X	X	X	X	L	H	H	H	H	H	H	H	2
RBI	H	L	L	L	L	L	L	H	H	H	H	H	H	H	3
LT	L	X	X	X	X	X	H	L	L	L	L	L	L	L	4

NOTES:

1. BI/RBO is wire-OR logic serving as blanking input (BI) and/or ripple-blanking output (RBO). The blanking input must be open or held at a high logic level when output functions 0 through 15 are desired, and ripple-blanking input (RBI) must be open or at a high logic level during the decimal 0 output. X = input may be high or low.
2. When a low logic level is applied to the blanking input (forced condition) all segment outputs go to a low logic level regardless of the state of any other input condition.
3. When ripple-blanking input (RBI) is at a low logic level, lamp test input is at high logic level and A = B = C = D = low logic level, all segment outputs go to a low logic level and the ripple-blanking output goes to a low logic level (response condition).
4. When blanking input/ripple-blanking output is open or held at a high logic level, and a low logic level is applied to lamp test input, all segment outputs go to a high logic level.

FIGURE 3. Truth tables - Continued.

Device type 08

DECIMAL OR FUNCTION	INPUTS							OUTPUTS							NOTE
	LT	RBI	D	C	B	A	BI/RBO	A	B	C	D	E	F	G	
0	H	H	L	L	L	L	H	H	H	H	H	H	H	L	1
1	H	X	L	L	L	H	H	L	H	H	L	L	L	L	1
2	H	X	L	L	H	L	H	H	H	L	H	H	L	H	
3	H	X	L	L	H	H	H	H	H	H	H	L	L	H	
4	H	X	L	H	L	L	H	L	H	H	L	L	H	H	
5	H	X	L	H	L	H	H	H	L	H	H	L	H	H	
6	H	X	L	H	H	L	H	L	L	H	H	H	H	H	
7	H	X	L	H	H	H	H	H	H	H	L	L	L	L	
8	H	X	H	L	L	L	H	H	H	H	H	H	H	H	
9	H	X	H	L	L	H	H	H	H	H	L	L	H	H	
10	H	X	H	L	H	L	H	L	L	L	H	H	L	H	
11	H	X	H	L	H	H	H	L	L	H	H	L	L	H	
12	H	X	H	H	L	L	H	L	H	L	L	L	H	H	
13	H	X	H	H	L	H	H	H	L	L	H	L	H	H	
14	H	X	H	H	H	L	H	L	L	L	H	H	H	H	
15	H	X	H	H	H	H	H	L	L	L	L	L	L	L	
BI	X	X	X	X	X	X	L	L	L	L	L	L	L	L	2
RBI	H	L	L	L	L	L	L	L	L	L	L	L	L	L	3
LT	L	X	X	X	X	X	H	H	H	H	H	H	H	H	4

NOTES:

1. BI/RBO is wire-OR logic serving as blanking input (BI) and/or ripple-blanking output (RBO). The blanking input must be open or held at a high logic level when output functions 0 through 15 are desired, and ripple-blanking input (RBI) must be open or at a high logic level during the decimal 0 output. X = input may be high or low.
2. When a low logic level is applied to the blanking input (forced condition) all segment outputs go to a low logic level regardless of the state of any other input condition.
3. When ripple-blanking input (RBI) is at a low logic level, lamp test input is at high logic level and A = B = C = D = low logic level, all segment outputs go to a low logic level and the ripple-blanking output goes to a low logic level (response condition).
4. When blanking input/ripple-blanking output is open or held at a high logic level, and a low logic level is applied to lamp test input, all segment outputs go to a high logic level.

FIGURE 3. Truth tables - Continued.

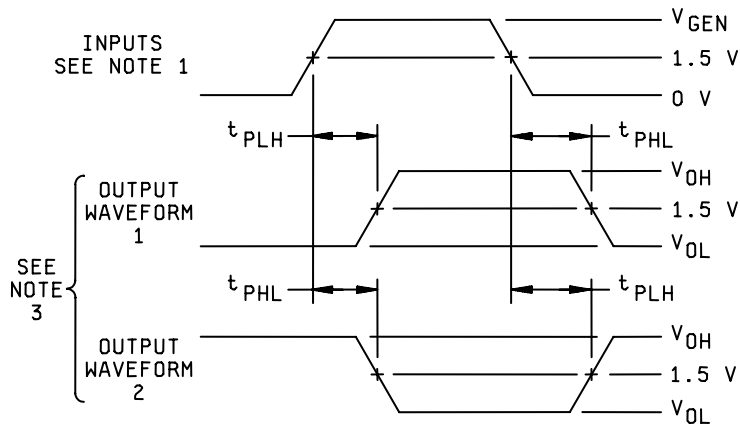
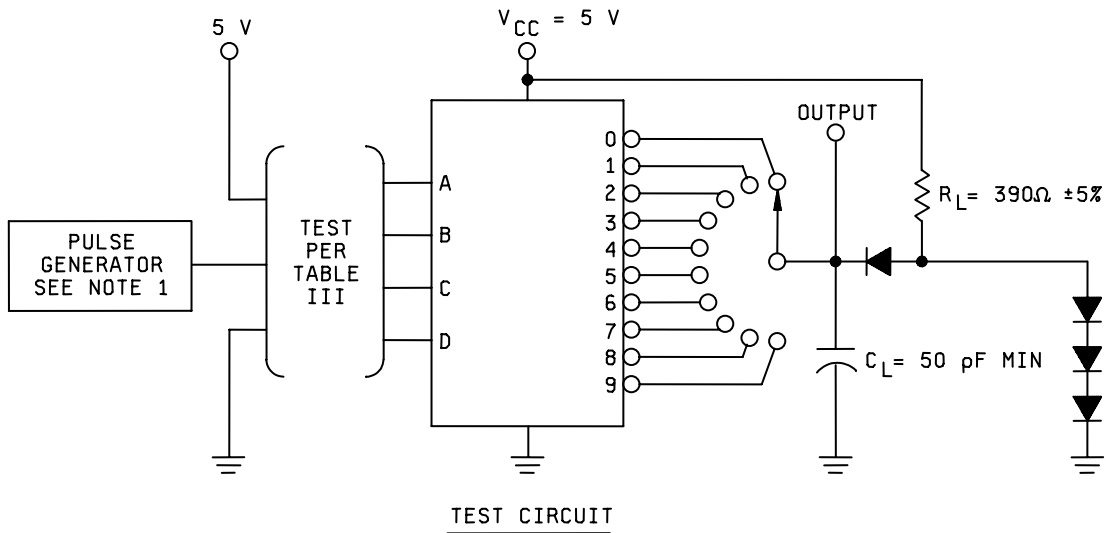
Device type 09

DECIMAL OR FUNCTION	INPUTS					OUTPUTS							NOTE
	D	C	B	A	BI	A	B	C	D	E	F	G	
0	L	L	L	L	H	H	H	H	H	H	H	L	1
1	L	L	L	H	H	L	H	H	L	L	L	L	
2	L	L	H	L	H	H	H	L	H	H	L	H	
3	L	L	H	H	H	H	H	H	H	L	L	H	
4	L	H	L	L	H	L	H	H	L	L	H	H	
5	L	H	L	H	H	H	L	H	H	L	H	H	
6	L	H	H	L	H	L	L	H	H	H	H	H	
7	L	H	H	H	H	H	H	H	L	L	L	L	
8	H	L	L	L	H	H	H	H	H	H	H	H	
9	H	L	L	H	H	H	H	H	L	L	H	H	
10	H	L	H	L	H	L	L	L	H	H	L	H	
11	H	L	H	H	H	L	L	H	H	L	L	H	
12	H	H	L	L	H	L	H	L	L	L	H	H	
13	H	H	L	H	H	H	L	L	H	L	H	H	
14	H	H	H	L	H	L	L	L	H	H	H	H	
15	H	H	H	H	H	L	L	L	L	L	L	L	
BI	X	X	X	X	L	L	L	L	L	L	L	L	2

NOTES:

1. The blanking input must be open or held at a high logic level when output functions 0 through 15 are desired.
2. When a low logic level is applied to the blanking input all segment outputs go to a low logic level regardless of the state of any other input condition. X = input may be high or low.

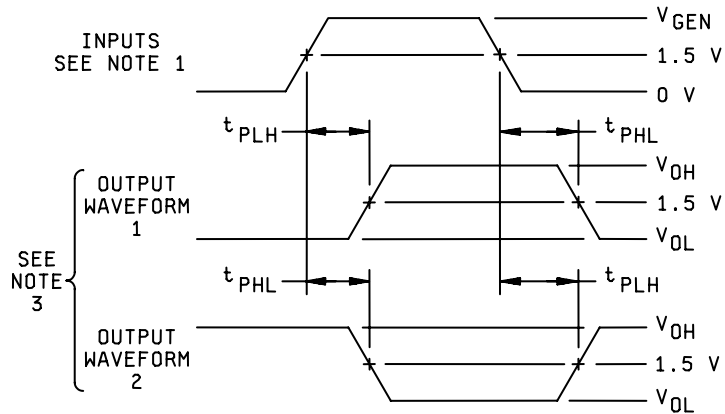
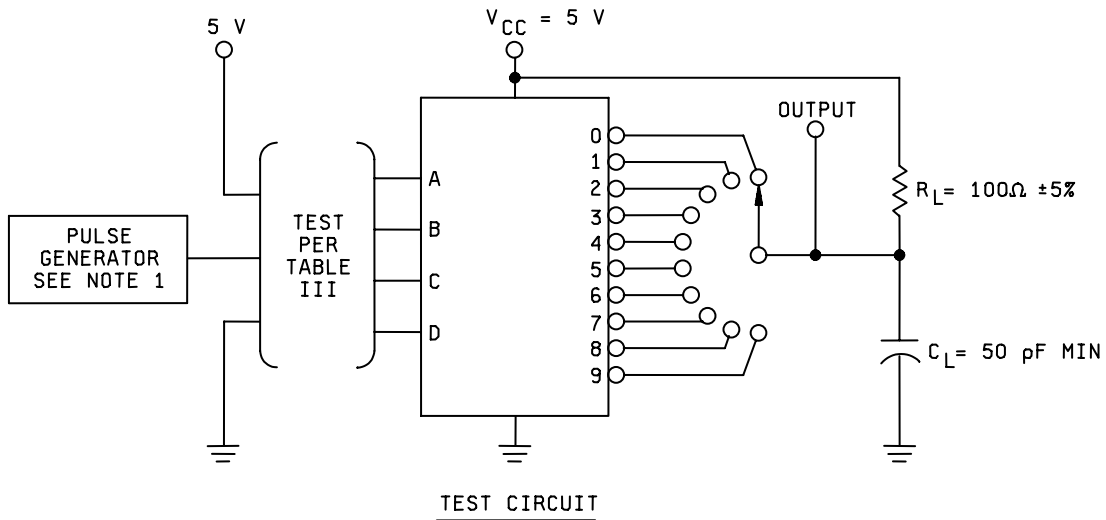
FIGURE 3. Truth tables - Continued.



NOTES:

1. The pulse generator has the following characteristics: $V_{GEN} = 3.0 \text{ V}$ minimum, t_{TLH} (0.7 V to 2.7 V) and t_{THL} (2.7 V to 0.7 V) $\leq 10 \text{ ns}$, PRR = 1 MHz, and minimum duty cycle = 50%.
2. C_L includes probe and jig capacitance.
3. Input - output waveform combination in accordance with the truth tables (see figure 3).
4. All diodes are 1N3064 or equivalent.

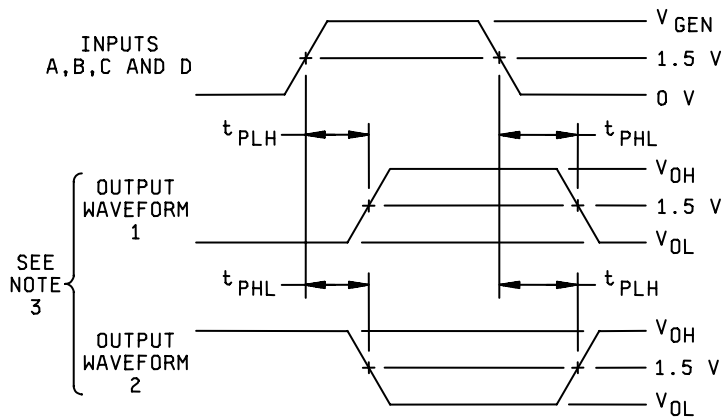
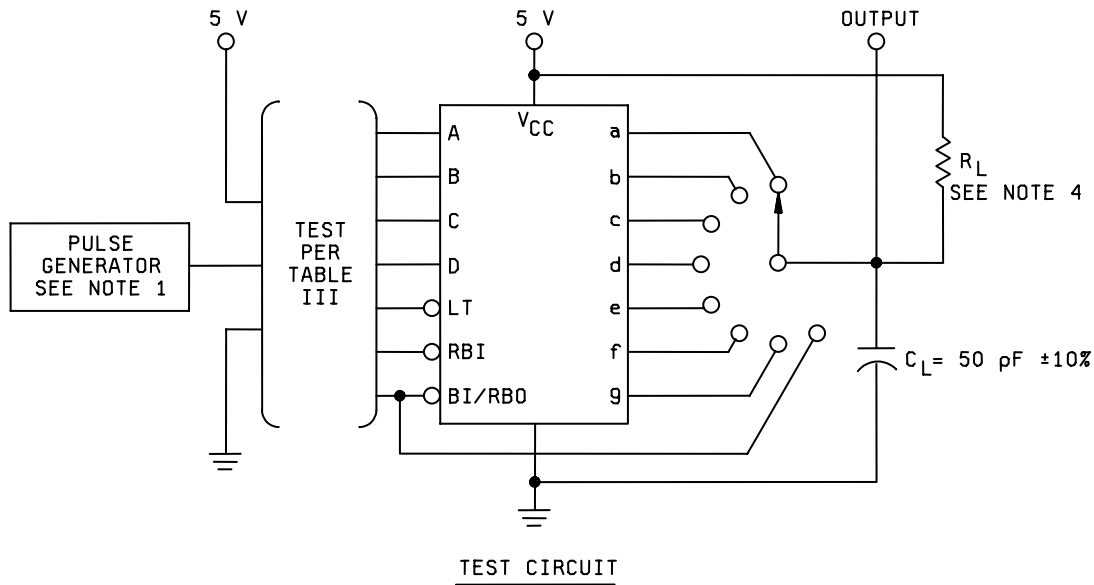
FIGURE 4. Switching times for device types 01, 02, and 03.



NOTES:

1. The pulse generator has the following characteristics: $V_{GEN} = 3.0 \text{ V}$ minimum, $t_{TLH} (0.7 \text{ V to } 2.7 \text{ V})$ and $t_{THL} (2.7 \text{ V to } 0.7 \text{ V}) \leq 10 \text{ ns}$, $PRR = 1 \text{ MHz}$, and minimum duty cycle = 50%.
2. C_L includes probe and jig capacitance.
3. Input - output waveform combination in accordance with the truth tables (see figure 3).

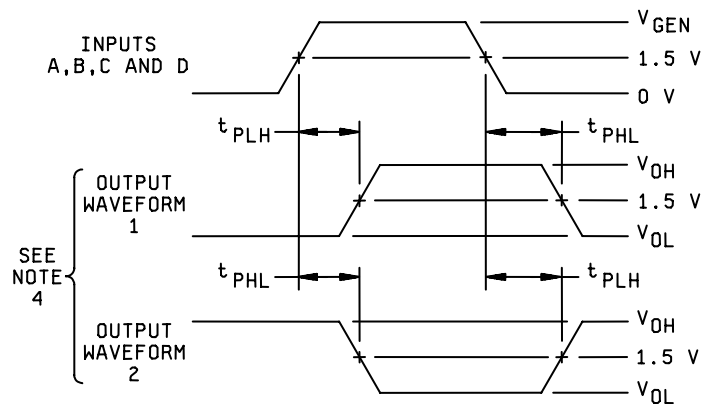
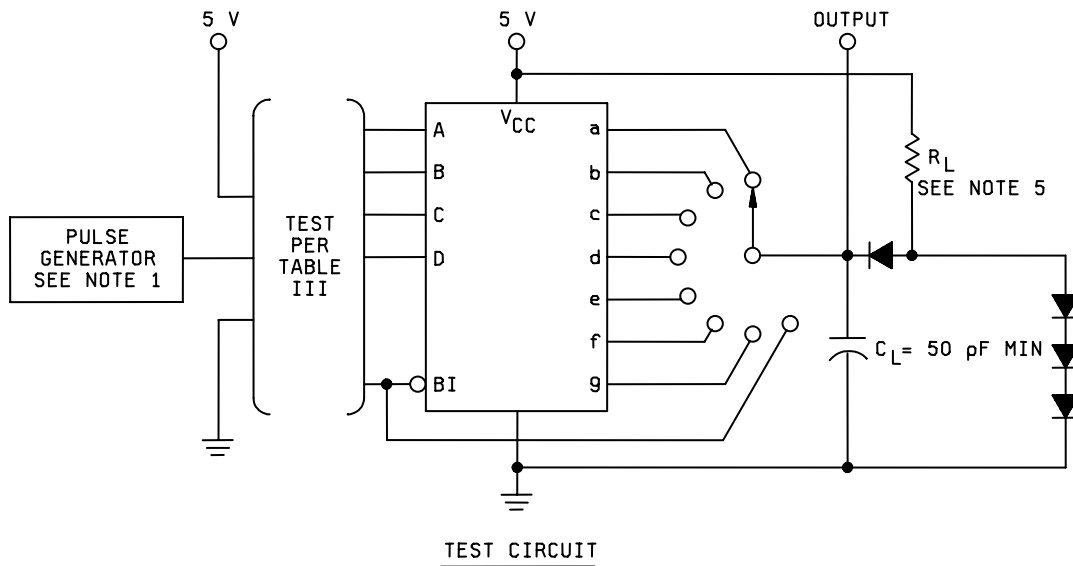
FIGURE 5. Switching times for device types 04 and 05.



NOTES:

1. The pulse generator has the following characteristics: $V_{GEN} = 3.0$ V minimum, t_{TLH} (0.7 V to 2.7 V) and t_{THL} (2.7 V to 0.7 V) ≤ 10 ns, PRR = 1 MHz, and minimum duty cycle = 50%.
2. C_L includes probe and jig capacitance.
3. Input - output waveform combination in accordance with the truth tables (see figure 3).
4. $R_L = 120 \Omega \pm 5\%$ for outputs A thru G; $R_L = 560 \Omega \pm 5\%$ for output BI/RBO.

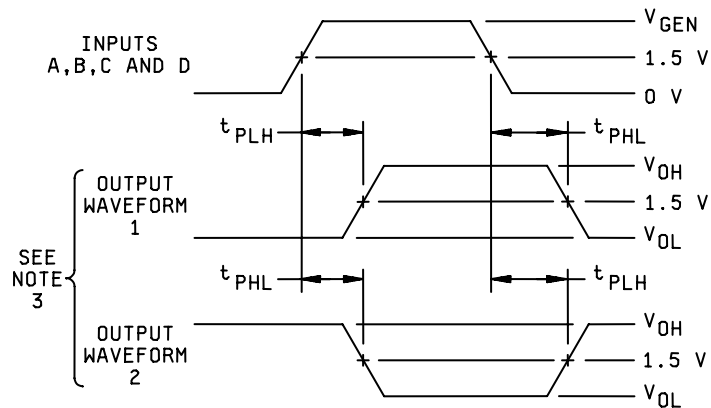
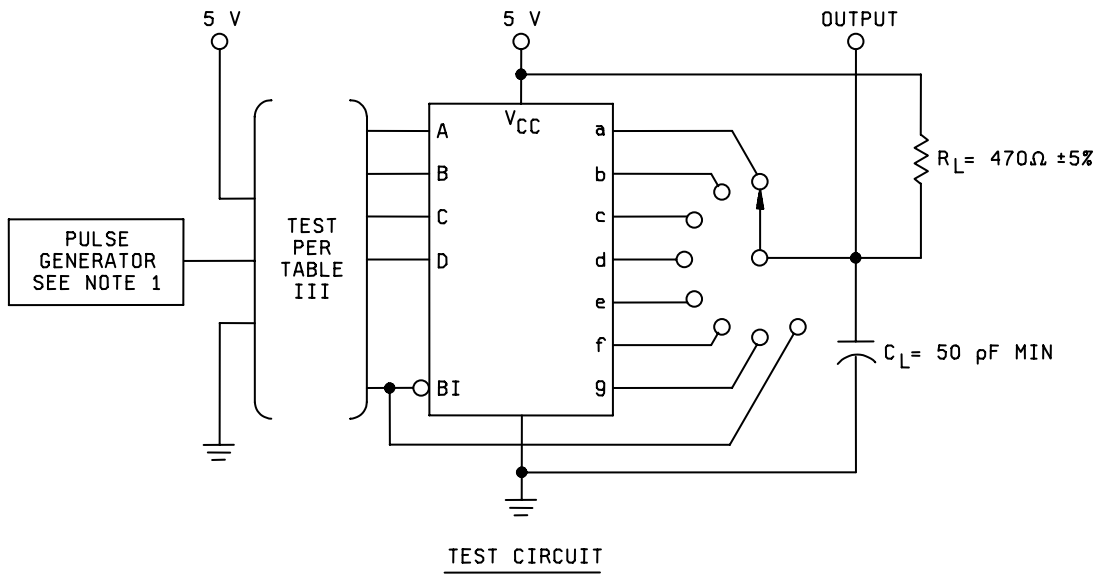
FIGURE 6. Switching times for device types 06 and 07.



NOTES:

1. The pulse generator has the following characteristics: $V_{GEN} = 3.0 \text{ V}$ minimum, $t_{TLH} (0.7 \text{ V to } 2.7 \text{ V})$ and $t_{THL} (2.7 \text{ V to } 0.7 \text{ V}) \leq 10 \text{ ns}$, $PRR = 1 \text{ MHz}$, and minimum duty cycle = 50%.
2. C_L includes probe and jig capacitance.
3. All diodes are 1N3064 or equivalent.
4. Input - output waveform combination in accordance with the truth tables (see figure 3).
5. $R_L = 750 \Omega \pm 5\%$ for outputs A thru G; $R_L = 560 \Omega \pm 5\%$ for output BI/RBO.

FIGURE 7. Switching times for device type 08.



NOTES:

1. The pulse generator has the following characteristics: $V_{GEN} = 3.0 \text{ V}$ minimum, $t_{TLH} (0.7 \text{ V to } 2.7 \text{ V})$ and $t_{THL} (2.7 \text{ V to } 0.7 \text{ V}) \leq 10 \text{ ns}$, $PRR = 1 \text{ MHz}$, and minimum duty cycle = 50%.
2. C_L includes probe and jig capacitance.
3. Input - output waveform combination in accordance with the truth tables (see figure 3).

FIGURE 8. Switching times for device type 09.

TABLE III. Group A inspection for device type 01.
Terminal conditions (pins not designated may be high ≥ 2.4 V or low ≤ 0.8 V; or open).

Subgroup	Symbol	MIL-STD-883 method	Cases E, F Test no.	1	2	3	4	5	6	7	8	9	10	11	12	13	14	15	16	Measured terminal	Limits		Unit
				0	1	2	3	4	5	6	GND	7	8	9	D	C	B	A	V _{CC}		Min	Max	
1 T _C = 25°C	V _{OH}	3006	1	-0.8 mA							GND				2.0 V	2.0 V	2.0 V	2.0 V	4.5 V	0	2.4 V		V
			2		-0.8 mA						"				"	"	"	"	"	1	"		"
			3			-0.8 mA					"				"	"	"	"	"	2	"		"
			4				-0.8 mA				"				"	"	"	"	"	3	"		"
			5					-0.8 mA			"				"	"	"	"	"	4	"		"
			6						-0.8 mA		"				"	"	"	"	"	5	"		"
			7							-0.8 mA	"				"	"	"	"	"	6	"		"
			8								"	-0.8 mA			"	"	"	"	"	7	"		"
			9								"		-0.8 mA		"	"	"	"	"	8	"		"
			10								"			-0.8 mA	"	"	"	"	"	9	"		"
V	O _L	3007	11	16 mA	16 mA	16 mA	16 mA	16 mA	16 mA	16 mA	"	16 mA	16 mA	16 mA	0.8 V	0.8 V	0.8 V	0.8 V	"	0		0.4 V	V
			12								"				"	"	0.8 V	2.0 V	"	1	"		"
			13								"				"	"	2.0 V	0.8 V	"	2	"		"
			14			16 mA					"				"	"	2.0 V	2.0 V	"	3	"		"
			15								"				"	2.0 V	0.8 V	0.8 V	"	4	"		"
			16						16 mA		"				"	"	0.8 V	2.0 V	"	5	"		"
			17							16 mA	"				"	"	2.0 V	0.8 V	"	6	"		"
			18								"	16 mA			"	"	2.0 V	2.0 V	"	7	"		"
			19								"		16 mA		"	0.8 V	0.8 V	0.8 V	"	8	"		"
			20								"			16 mA	2.0 V	0.8 V	0.8 V	2.0 V	"	9	"		"
V	I _C		21								"						-12 mA	-12 mA	"	A		-1.5	V
			22								"								"	B		"	"
			23								"								"	C		"	"
			24								"				-12 mA	-12 mA			"	D		"	"
I	IH1	3010	25								"				GND	GND	GND	2.4 V	5.5 V	A		40	μA
			26								"				"	GND	2.4 V	GND	"	B		"	"
			27								"				"	2.4 V	GND	"	"	C		"	"
			28								"				"	GND	"	"	"	D		"	"
I	IH2	3010	29								"				GND	"	"	5.5 V	"	A		100	μA
			30								"				"	"	5.5 V	GND	"	B		"	"
			31								"				"	5.5 V	GND	"	"	C		"	"
			32								"				5.5 V	GND	GND	"	"	D		"	"
I	IL	3009	33								"				"	5.5 V	5.5 V	0.4 V	"	A	-0.7	-1.6	mA
			34								"				"	5.5 V	0.4 V	5.5 V	"	B	"	"	"
			35								"				"	0.4 V	5.5 V	"	"	C	"	"	"
			36								"				0.4 V	5.5 V	5.5 V	"	"	D	"	"	"
I	OS	3011	37	GND	GND	GND	GND	GND	GND	GND	"				5.5 V	5.5 V	5.5 V	5.5 V	"	0	-20	-55	mA
			38								"				"	"	"	"	"	1	"		"
			39								"				"	"	"	"	"	2	"		"
			40				GND				"				"	"	"	"	"	3	"		"
			41					GND			"				"	"	"	"	"	4	"		"
			42						GND		"				"	"	"	"	"	5	"		"
			43							GND	"				"	"	"	"	"	6	"		"
			44								"	GND			"	"	"	"	"	7	"		"
			45								"		GND		"	"	"	"	"	8	"		"
			46								"			GND	"	"	"	"	"	9	"		"
	CC	3005	47								"				GND	GND	GND	GND	"	V _{CC}		41	mA
2	Same tests, terminal conditions, and limits as subgroup 1, except T _C = +125°C and V _I C tests are omitted.																						
3	Same tests, terminal conditions, and limits as subgroup 1, except T _C = -55°C and V _I C tests are omitted.																						

See footnotes at end of device type 01.

TABLE III. Group A inspection for device type 01.
Terminal conditions (pins not designated may be high ≥ 2.4 V or low ≤ 0.8 V; or open).

Subgroup	Symbol	MIL-STD-883 method	Cases E, F	1	2	3	4	5	6	7	8	9	10	11	12	13	14	15	16	Measured terminal	Limits		Unit			
			Test no.	0	1	2	3	4	5	6	GND	7	8	9	D	C	B	A	V _{CC}		Min	Max				
7 T _C = 25°C	Truth table test		48	L	H	H	H	H	H	H	GND	H	H	H	GND	GND	GND	GND	5.0 V	See note						
			49	H	L	H	"	"	"	"	"	"	"	"	"	"	"	GND	5.0 V				"			
			50	"	H	L	"	"	"	"	"	"	"	"	"	"	"	5.0 V	GND				"			
			51	"	"	H	L	"	"	"	"	"	"	"	"	"	"	5.0 V	5.0 V				"			
			52	"	"	"	H	L	"	"	"	"	"	"	"	"	5.0 V	GND	GND				"			
			53	"	"	"	"	L	H	"	"	"	"	"	"	"	5.0 V	GND	5.0 V				"			
			54	"	"	"	"	"	H	L	"	"	"	"	"	"	"	5.0 V	GND				"			
			55	"	"	"	"	"	"	"	L	H	"	"	"	"	"	5.0 V	5.0 V				"			
			56	"	"	"	"	"	"	"	"	H	"	"	"	"	"	GND	GND				"			
			57	"	"	"	"	"	"	"	"	"	L	H	"	"	5.0 V	GND	5.0 V				"			
			58	"	"	"	"	"	"	"	"	"	"	"	L	H	"	5.0 V	GND				"			
			59	"	"	"	"	"	"	"	"	"	"	"	"	"	"	5.0 V	5.0 V				"			
			60	"	"	"	"	"	"	"	"	"	"	"	"	"	"	GND	GND				"			
			61	"	"	"	"	"	"	"	"	"	"	"	"	"	"	GND	5.0 V				"			
			62	"	"	"	"	"	"	"	"	"	"	"	"	"	"	5.0 V	GND				"			
			63	"	"	"	"	"	"	"	"	"	"	"	"	"	"	5.0 V	5.0 V				"			
8	Truth table test		64 thru 79	Same tests as subgroup 7, except T _C = +125°C.																						
			80 thru 95	Same tests as subgroup 7, except T _C = -55°C.																						
9 T _C = 25°C	t _{PHL} t _{PLH}	3003 (Fig. 4)	96 & 97	OUT	OUT						GND				GND	GND	GND	IN	5.0 V	A to 0	5	32	ns			
			98 & 99								"	OUT			"	"	5.0 V	"	"	A to 1	"	37	"			
			100 & 101		OUT						"	"			"	"	"	5.0 V	IN	5.0 V	"	A to 7	"	37	"	
			102 & 103								"	"			"	"	"	5.0 V	"	GND	"	B to 1	"	32	"	
			104 & 105								"	"			"	"	"	5.0 V	"	GND	"	B to 4	"	32	"	
			106 & 107			OUT		OUT			"	"			"	"	"	GND	"	GND	"	B to 2	"	37	"	
			108 & 109			OUT					"	"			"	"	"	IN	5.0 V	GND	"	C to 2	"	32	"	
			110 & 111				OUT				"	"			"	"	"	5.0 V	5.0 V	"	C to 3	"	"	"		
			112 & 113								"	"	OUT		"	"	"	"	GND	GND	"	C to 8	"	"	"	
			114 & 115								"	"		OUT	"	"	"	"	"	5.0 V	"	C to 9	"	"	"	
			116 & 117								"	"			"	"	"	"	"	GND	"	C to 4	"	37	"	
			118 & 119								"	"			"	"	"	"	"	5.0 V	"	C to 5	"	"	"	
			120 & 121								"	"	OUT	OUT	"	"	"	"	"	5.0 V	"	C to 6	"	"	"	
			122 & 123								"	"			"	"	"	"	"	"	5.0 V	"	C to 7	"	"	"
			124 & 125				OUT				"	"			"	"	"	"	"	5.0 V	"	D to 3	"	32	"	
			126 & 127					OUT			"	"			"	"	"	"	"	5.0 V	"	D to 4	"	"	"	
128 & 129						OUT		"	"			"	"	"	"	"	GND	5.0 V	"	D to 5	"	"	"			
130 & 131							OUT	"	"	OUT		"	"	"	"	"	5.0 V	GND	"	D to 6	"	"	"			
132 & 133								"	"		OUT		"	"	"	"	5.0 V	5.0 V	"	D to 7	"	"	"			
134 & 135								"	"			OUT	"	"	"	"	5.0 V	GND	"	D to 8	"	37	"			
136 & 137								"	"				OUT	"	"	"	5.0 V	"	D to 9	"	37	"				
10 T _C = 125°C	t _{PHL} t _{PLH}	3003 (Fig. 4)	138 & 139	OUT	OUT						"				GND	"	"	IN	"	A to 0	"	39	"			
			140 & 141								"				"	"	"	"	"	A to 1	"	46	"			
			142 & 143		OUT						"	OUT			"	5.0 V	5.0 V	"	"	A to 7	"	46	"			
			144 & 145								"	"			"	GND	IN	5.0 V	"	B to 1	"	39	"			
			146 & 147								"	"			"	5.0 V	"	GND	"	B to 4	"	39	"			
			148 & 149								"	"			"	GND	"	GND	"	B to 2	"	46	"			
			150 & 151			OUT					"	"			"	"	IN	5.0 V	GND	"	C to 2	"	39	"		
			152 & 153				OUT				"	"			"	"	5.0 V	5.0 V	"	C to 3	"	"	"			
			154 & 155								"	"			"	"	"	GND	GND	"	C to 8	"	"	"		
			156 & 157								"	"			"	"	"	5.0 V	"	C to 9	"	"	"			
			158 & 159								"	"			"	"	"	"	GND	"	C to 4	"	46	"		
			160 & 161								"	"			"	"	"	"	5.0 V	"	C to 5	"	"	"		
			162 & 163								"	"			"	"	"	"	5.0 V	GND	"	C to 6	"	"	"	
			164 & 165								"	"			"	"	"	"	"	5.0 V	"	C to 7	"	"	"	
			166 & 167								"	"			"	"	"	"	5.0 V	"	D to 3	"	39	"		
			168 & 169				OUT			OUT	"	"			"	"	"	"	GND	GND	"	D to 4	"	"	"	
170 & 171								"	"	OUT		"	"	"	"	GND	5.0 V	"	D to 5	"	"	"				
172 & 173								"	"		OUT	"	"	"	"	5.0 V	GND	"	D to 6	"	"	"				
174 & 175								"	"			"	"	"	"	5.0 V	5.0 V	"	D to 7	"	"	"				
176 & 177								"	"			"	"	"	"	GND	GND	"	D to 8	"	46	"				
178 & 179								"	"			"	"	"	"	GND	5.0 V	"	D to 9	"	46	"				
11	Same tests, terminal conditions, and limits as subgroup 10, except T _C = -55°C.																									

NOTE: Output voltages shall be either: (a) H = 2.4 V minimum and L = 0.4 V maximum when using a high speed checker double comparator, or (b) H ≥ 1.5 V and L ≤ 1.5 V when using a high speed checker single comparator.

TABLE III. Group A inspection for device type 02.
Terminal conditions (pins not designated may be high ≥ 2.4 V or low ≤ 0.8 V; or open).

Subgroup	Symbol	MIL-STD-883 method	Cases E, F	1	2	3	4	5	6	7	8	9	10	11	12	13	14	15	16	Measured terminal	Limits		Unit
			Test no.	0	1	2	3	4	5	6	GND	7	8	9	D	C	B	A	V _{CC}		Min	Max	
1 T _C = 25°C	V _{OH}	3006	1	-0.8 mA	-0.8 mA	-0.8 mA	-0.8 mA	-0.8 mA	-0.8 mA	-0.8 mA	GND	-0.8 mA	-0.8 mA	-0.8 mA	2.0 V	2.0 V	2.0 V	2.0 V	4.5 V	0	2.4 V		V
		"	2	"							1				"	"							
		"	3	"							2				"	"							
		"	4	"							3				"	"							
		"	5	"							4				"	"							
		"	6	"							5				"	"							
		"	7	"							6				"	"							
		"	8	"							7				"	"							
		"	9	"							8				"	"							
		"	10	"							9				"	"							
V	O _L	3007	11	16 mA	16 mA	16 mA	16 mA	16 mA	16 mA	16 mA	"	16 mA	16 mA	16 mA	0.8 V	0.8 V	2.0 V	2.0 V	"	0		0.4 V	V
		"	12	"							1				"	"							
		"	13	"							2				"	"							
		"	14	"							3				"	"							
		"	15	"							4				"	"							
		"	16	"							5				"	"							
		"	17	"							6				"	"							
		"	18	"							7				"	"							
		"	19	"							8				"	"							
		"	20	"							9				"	"							
V	I _C		21							"						-12 mA	-12 mA	-12 mA	"	A		-1.5	V
			22							"									B	"			
			23							"									C	"			
			24							"				-12 mA	-12 mA			D	"				
I	IH1	3010	25							"					GND	GND	GND	2.4 V	5.5 V	A		40	μA
		"	26							"					GND	2.4 V	GND	"	B	"			
		"	27							"					2.4 V	GND	"	"	C	"			
		"	28							"					GND	"	"	"	D	"			
I	IH2	3010	29							"					GND	"	"	5.5 V	"	A		100	μA
		"	30							"				"	"	5.5 V	GND	"	B	"			
		"	31							"				"	5.5 V	GND	"	"	C	"			
		"	32							"				5.5 V	GND	GND	"	"	D	"			
I	IL	3009	33							"					"	5.5 V	5.5 V	0.4 V	"	A	-0.7	-1.6	mA
		"	34							"				"	5.5 V	0.4 V	5.5 V	"	B				
		"	35							"				"	0.4 V	5.5 V	"	"	C				
		"	36							"				0.4 V	5.5 V	5.5 V	"	"	D				
I	O _S	3011	37	GND	GND	GND	GND	GND	GND	GND	"	GND	GND	GND	5.5 V	5.5 V	5.5 V	5.5 V	"	0	-20	-55	mA
		"	38	"							1				"	"							
		"	39	"							2				"	"							
		"	40	"							3				"	"							
		"	41	"							4				"	"							
		"	42	"							5				"	"							
		"	43	"							6				"	"							
		"	44	"							7				"	"							
		"	45	"							8				"	"							
		"	46	"							9				"	"							
	CC	3005	47							"				GND	GND	GND	GND	"	V _{CC}		41	mA	
2	Same tests, terminal conditions, and limits as subgroup 1, except T _C = +125°C and V _I C tests are omitted.																						
3	Same tests, terminal conditions, and limits as subgroup 1, except T _C = -55°C and V _I C tests are omitted.																						

See footnotes at end of device type 01.

TABLE III. Group A inspection for device type 02.
Terminal conditions (pins not designated may be high ≥ 2.4 V or low ≤ 0.8 V; or open).

Subgroup	Symbol	MIL-STD-883 method	Cases E, F	1	2	3	4	5	6	7	8	9	10	11	12	13	14	15	16	Measured terminal	Limits		Unit																
			Test no.	0	1	2	3	4	5	6	GND	7	8	9	D	C	B	A	V _{CC}		Min	Max																	
7 T _C = 25°C	Truth table test		48	L	H	H	H	H	H	H	GND	H	H	H	GND	GND	5.0 V	5.0 V	5.0 V	See note																			
			49	H	L	H	H	"	"	"	"	"	"	"	"	5.0 V	GND	GND	"																				
			50	"	H	L	"	"	"	"	"	"	"	"	"	"	GND	5.0 V	"																				
			51	"	"	H	L	"	"	"	"	"	"	"	"	"	5.0 V	GND	"																				
			52	"	"	"	H	L	"	"	"	"	"	"	"	"	5.0 V	5.0 V	"																				
			53	"	"	"	"	H	L	"	"	"	"	"	5.0 V	GND	GND	GND	"																				
			54	"	"	"	"	"	"	L	H	"	"	"	"	"	GND	5.0 V	"																				
			55	"	"	"	"	"	"	"	H	"	"	"	"	"	5.0 V	GND	"																				
			56	"	"	"	"	"	"	"	"	L	H	"	"	"	5.0 V	5.0 V	"																				
			57	"	"	"	"	"	"	"	"	"	L	H	"	"	5.0 V	GND	GND				"																
			58	"	"	"	"	"	"	"	"	"	"	"	L	H	"	GND	5.0 V				"																
			59	"	"	"	"	"	"	"	"	"	"	"	"	"	"	5.0 V	GND				"																
			60	"	"	"	"	"	"	"	"	"	"	"	"	"	"	5.0 V	5.0 V				"																
			61	"	"	"	"	"	"	"	"	"	"	"	"	GND	GND	GND	"																				
			62	"	"	"	"	"	"	"	"	"	"	"	"	"	GND	5.0 V	"																				
			63	"	"	"	"	"	"	"	"	"	"	"	"	"	"	5.0 V	GND				"																
			8	Truth table test		64 thru 79	Same tests as subgroup 7, except T _C = +125°C.																																
80 thru 95	Same tests as subgroup 7, except T _C = -55°C.																																						
9 T _C = 25°C	t _{PHL} t _{PLH}	3003 (Fig. 4)	96 & 97	OUT	OUT	OUT	OUT	OUT	OUT	OUT	OUT	OUT	OUT	OUT	OUT	OUT	OUT	OUT	OUT	OUT	OUT	OUT																	
			98 & 99																																				
			100 & 101																																				
			102 & 103																																				
			"	OUT	OUT	OUT	OUT	OUT	OUT	OUT	OUT	OUT	OUT	OUT	OUT	OUT	OUT	OUT	OUT	OUT																			
			104 & 105																																				
			106 & 107																																				
			108 & 109																																				
			"	OUT	OUT	OUT	OUT	OUT	OUT	OUT	OUT	OUT	OUT	OUT	OUT	OUT	OUT	OUT	OUT	OUT	OUT																		
			110 & 111																																				
			112 & 113																																				
			114 & 115																																				
			"	OUT	OUT	OUT	OUT	OUT	OUT	OUT	OUT	OUT	OUT	OUT	OUT	OUT	OUT	OUT	OUT	OUT	OUT	OUT																	
			116 & 117																																				
			118 & 119																																				
			120 & 121																																				
			"	OUT	OUT	OUT	OUT	OUT	OUT	OUT	OUT	OUT	OUT	OUT	OUT	OUT	OUT	OUT	OUT	OUT	OUT	OUT	OUT																
			122 & 123																																				
			124 & 125																																				
			126 & 127																																				
			"	OUT	OUT	OUT	OUT	OUT	OUT	OUT	OUT	OUT	OUT	OUT	OUT	OUT	OUT	OUT	OUT	OUT	OUT	OUT	OUT																
			128 & 129																																				
			130 & 131																																				
			132 & 133																																				
			"	OUT	OUT	OUT	OUT	OUT	OUT	OUT	OUT	OUT	OUT	OUT	OUT	OUT	OUT	OUT	OUT	OUT	OUT	OUT	OUT																
			134 & 135																																				
			136 & 137																																				
138 & 139																																							
"	OUT	OUT	OUT	OUT	OUT	OUT	OUT	OUT	OUT	OUT	OUT	OUT	OUT	OUT	OUT	OUT	OUT	OUT	OUT	OUT																			
140 & 141																																							
142 & 143																																							

TABLE III. Group A inspection for device type 02.
Terminal conditions (pins not designated may be high ≥ 2.4 V or low ≤ 0.8 V; or open).

Subgroup	Symbol	MIL-STD-883 method	Cases E, F	1	2	3	4	5	6	7	8	9	10	11	12	13	14	15	16	Measured terminal	Limits		Unit		
			Test no.	0	1	2	3	4	5	6	GND	7	8	9	D	C	B	A	V _{CC}		Min	Max			
10 T _c = 125°C	t _{PHL} t _{PLH}	3003 (Fig. 4)	144 & 145	OUT	OUT						GND	OUT		OUT	GND	5.0 V	GND	IN	5.0 V	A to 1	5	39	ns		
			146 & 147												GND	5.0 V	"	"	A to 7	"	"	"			
			148 & 149												"	5.0 V	GND	"	"	A to 9	"	"	"		
			150 & 151												"	GND	GND	5.0 V	"	A to 0	"	46	"		
			152 & 153												"	5.0 V	GND	GND	"	A to 6	"	46	"		
			154 & 155												OUT	"	IN	5.0 V	"	B to 2	"	39	"		
			156 & 157													"	GND	"	5.0 V	"	B to 6	"	39	"	
			158 & 159													"	5.0 V	"	GND	"	B to 9	"	39	"	
			160 & 161													OUT	"	5.0 V	"	GND	"	B to 3	"	46	"
			162 & 163														"	GND	"	GND	"	B to 7	"	46	"
			164 & 165														"	GND	"	5.0 V	"	B to 8	"	46	"
			166 & 167												OUT	"	IN	5.0 V	"	C to 0	"	39	"		
			168 & 169	"	5.0 V	"	GND	"	C to 5	"	39	"													
			170 & 171	"	5.0 V	"	5.0 V	"	C to 8	"	39	"													
			172 & 173	OUT	"	GND	"	GND	"	C to 1	"	46	"												
			174 & 175		"	GND	"	5.0 V	"	C to 2	"	"	"												
			176 & 177		"	GND	"	5.0 V	"	C to 4	"	"	"												
			178 & 179	OUT	"	"	GND	"	C to 9	"	"	"	"												
			180 & 181		"	5.0 V	"	GND	"	D to 3	"	34	"												
			182 & 183		OUT	"	5.0 V	"	5.0 V	"	D to 4	"	34	"											
			184 & 185			"	GND	"	GND	"	D to 5	"	46	"											
			186 & 187			OUT	"	"	5.0 V	"	D to 6	"	"	"											
			188 & 189		"		5.0 V	"	GND	"	D to 7	"	"	"											
			190 & 191	"	5.0 V		5.0 V	"	D to 8	"	"	"	"												
11	Same tests, terminal conditions, and limits as subgroup 10, except T _c = -55°C.																								

NOTE: Output voltages shall be either: (a) H = 2.4 V minimum and L = 0.4 V maximum when using a high speed checker double comparator, or (b) H ≥ 1.5 V and L ≤ 1.5 V when using a high speed checker single comparator.

TABLE III. Group A inspection for device type 03.
Terminal conditions (pins not designated may be high ≥ 2.4 V or low ≤ 0.8 V; or open).

Subgroup	Symbol	MIL-STD-883 method	Cases E, F	1	2	3	4	5	6	7	8	9	10	11	12	13	14	15	16	Measured terminal	Limits		Unit
			Test no.	0	1	2	3	4	5	6	GND	7	8	9	D	C	B	A	V _{CC}		Min	Max	
1 T _C = 25°C	V _{OH}	3006	1	-0.8 mA							GND				0.8 V	0.8 V	0.8 V	0.8 V	4.5 V	0	2.4 V		V
		"	2		-0.8 mA						"				"	"	"	"	"	1	"		"
		"	3			-0.8 mA					"				"	"	"	"	"	2	"		"
		"	4				-0.8 mA				"				"	"	"	"	"	3	"		"
		"	5					-0.8 mA			"				"	"	"	"	"	4	"		"
		"	6						-0.8 mA		"				"	"	"	"	"	5	"		"
		"	7							-0.8 mA	"				"	"	"	"	"	6	"		"
		"	8								"	-0.8 mA			"	"	"	"	"	7	"		"
		"	9								"		-0.8 mA		"	"	"	"	"	8	"		"
		"	10								"			-0.8 mA	"	"	"	"	"	9	"		"
	V	3007	11	16 mA	16 mA						"				0.8 V	0.8 V	2.0 V	0.8 V	"	0		0.4 V	V
		"	12								"				"	2.0 V	"	0.8 V	"	1		"	"
		"	13			16 mA					"				"	"	0.8 V	2.0 V	"	2		"	"
		"	14				16 mA				"				"	"	"	2.0 V	"	3		"	"
		"	15					16 mA			"				"	"	"	0.8 V	"	4		"	"
		"	16						16 mA		"				2.0 V	"	"	0.8 V	"	5		"	"
		"	17							16 mA	"				"	"	"	2.0 V	"	6		"	"
		"	18								"	16 mA			"	"	2.0 V	2.0 V	"	7		"	"
		"	19								"		16 mA		"	"	0.8 V	0.8 V	"	8		"	"
		"	20								"			16 mA	"	0.8 V	0.8 V	"	"	9		"	"
V	I _C		21								"						-12 mA	-12 mA	"	A		-1.5	V
			22								"								"	B		"	"
			23								"								"	C		"	"
			24								"				-12 mA	-12 mA			"	D		"	"
	I _{H1}	3010	25								"				GND	GND	GND	2.4 V	5.5 V	A		40	μA
		"	26								"				"	GND	2.4 V	GND	"	B		"	"
		"	27								"				"	2.4 V	GND	"	"	C		"	"
		"	28								"				2.4 V	GND	"	"	"	D		"	"
	I	3010	29								"				GND	"	"	5.5 V	5.5 V	A		100	"
		"	30								"				"	"	GND	GND	"	B		"	"
		"	31								"				"	5.5 V	GND	"	"	C		"	"
		"	32								"				5.5 V	GND	GND	"	"	D		"	"
I	I _L	3009	33								"				"	5.5 V	5.5 V	0.4 V	"	A	-0.7	-1.6	mA
		"	34								"				"	5.5 V	0.4 V	5.5 V	"	B	"	"	"
		"	35								"				"	0.4 V	5.5 V	"	"	C	"	"	"
		"	36								"				0.4 V	5.5 V	5.5 V	"	"	D	"	"	"
	I	3011	37	GND	GND	GND	GND	GND	GND	GND	"				GND	GND	GND	GND	"	0	-20	-55	mA
		"	38								"				"	"	"	"	"	1	"	"	"
		"	39								"				"	"	"	"	"	2	"	"	"
		"	40								"				"	"	"	"	"	3	"	"	"
		"	41								"				"	"	"	"	"	4	"	"	"
		"	42								"				"	"	"	"	"	5	"	"	"
		"	43								"				"	"	"	"	"	6	"	"	"
		"	44								"	GND			"	"	"	"	"	7	"	"	"
		"	45								"		GND		"	"	"	"	"	8	"	"	"
		"	46								"			GND	"	"	"	"	"	9	"	"	"
	CC	3005	47								"				GND	GND	GND	GND	"	V _{CC}		41	mA
2	Same tests, terminal conditions, and limits as subgroup 1, except T _C = +125°C and V _{I_C} tests are omitted.																						
3	Same tests, terminal conditions, and limits as subgroup 1, except T _C = -55°C and V _{I_C} tests are omitted.																						

See footnotes at end of device type 03.

TABLE III. Group A inspection for device type 03.
Terminal conditions (pins not designated may be high ≥ 2.4 V or low ≤ 0.8 V; or open).

Subgroup	Symbol	MIL-STD-883 method	Cases E, F	1	2	3	4	5	6	7	8	9	10	11	12	13	14	15	16	Measured terminal	Limits		Unit				
			Test no.	0	1	2	3	4	5	6	GND	7	8	9	D	C	B	A	V _{CC}		Min	Max					
7 T _C = 25°C	Truth table test		48	L	H	H	H	H	H	H	GND	H	H	H	GND	GND	5.0 V	GND	5.0 V	See note							
			49	H	L	H	"	"	"	"	"	"	"	"	"	5.0 V	5.0 V	GND	"								
			50	"	H	L	"	"	"	"	"	"	"	"	"	"	5.0 V	5.0 V	"								
			51	"	"	H	L	"	"	"	"	"	"	"	"	"	GND	5.0 V	"								
			52	"	"	"	H	L	"	"	"	"	"	"	"	"	"	GND	"								
			53	"	"	"	"	H	L	"	"	"	"	"	5.0 V	"	"	GND	"								
			54	"	"	"	"	"	"	L	H	L	"	"	"	"	"	5.0 V	"								
			55	"	"	"	"	"	"	"	H	"	"	"	"	"	5.0 V	5.0 V	"								
			56	"	"	"	"	"	"	"	"	L	H	L	"	"	"	GND	"								
			57	"	"	"	"	"	"	"	"	"	"	H	"	GND	"	GND	"								
			58	"	"	"	"	"	"	"	"	"	"	"	L	"	"	5.0 V	"								
			59	"	"	"	"	"	"	"	"	"	"	"	"	"	GND	5.0 V	"								
			60	"	"	"	"	"	"	"	"	"	"	"	"	"	"	GND	"								
			61	"	"	"	"	"	"	"	"	"	"	"	"	GND	"	GND	"								
			62	"	"	"	"	"	"	"	"	"	"	"	"	"	"	5.0 V	"								
			63	"	"	"	"	"	"	"	"	"	"	"	"	"	"	5.0 V	"								
			8	Truth table test		64 thru 79	Same tests as subgroup 7, except T _C = +125°C.																				
						80 thru 95	Same tests as subgroup 7, except T _C = -55°C.																				
9 T _C = 25°C	t _{PHL} t _{PLH}	3003 (Fig. 4)	96 & 97	OUT		OUT	OUT	OUT	OUT	OUT	GND		OUT		GND	GND	5.0 V	IN	5.0 V	A to 0	5	32	ns				
			98 & 99	5.0 V											5.0 V	IN	A to 8										
			"	GND											"	5.0 V	IN	A to 2									
			"	GND											"	IN	B to 3										
			"	GND											"	GND	B to 4										
			"	5.0 V											"	GND	B to 5										
			"	5.0 V											"	5.0 V	B to 6										
			"	GND											GND	GND	B to 0										
			"	GND											5.0 V	GND	B to 1										
			"	GND											5.0 V	5.0 V	B to 2										
			"	5.0 V	5.0 V	GND	B to 8																				
			"	5.0 V	IN	5.0 V	GND	C to 9																			
			"	GND	"	5.0 V	GND	C to 1																			
			"	GND	"	GND	5.0 V	C to 3																			
			"	GND	"	GND	"	C to 4																			
			"	5.0 V	"	GND	"	C to 5																			
			"	5.0 V	"	5.0 V	"	C to 6																			
			"	5.0 V	"	5.0 V	"	C to 7																			
			"	IN	5.0 V	GND	"	D to 1																			
			"	"	5.0 V	5.0 V	"	D to 2																			
			"	"	"	GND	5.0 V	D to 4																			
			"	"	"	GND	"	D to 5																			
			"	"	"	GND	5.0 V	D to 6																			
			"	"	5.0 V	5.0 V	"	D to 7																			
			"	"	GND	5.0 V	GND	D to 9																			

See notes at end of device type 03.

TABLE III. Group A inspection for device type 03.
Terminal conditions (pins not designated may be high ≥ 2.4 V or low ≤ 0.8 V; or open).

Subgroup	Symbol	MIL-STD-883 method	Cases E, F	1	2	3	4	5	6	7	8	9	10	11	12	13	14	15	16	Measured terminal	Limits		Unit		
			Test no.	0	1	2	3	4	5	6	GND	7	8	9	D	C	B	A	V _{CC}		Min	Max			
10 T _C = 125°C	t _{PHL} t _{PLH}	3003 (Fig. 4)	146 & 147	OUT							GND				GND	GND	5.0 V	IN	5.0 V	A to 0	5	39	ns		
			148 & 149								"		OUT		5.0 V	5.0 V	5.0 V	IN	"	A to 8	"	39	"		
			"	150 & 151			OUT	OUT				"				GND	"	5.0 V	IN	"	A to 2	"	46	"	
			"	152 & 153								"				GND	"	IN	5.0 V	"	B to 3	"	39	"	
			"	154 & 155				OUT	OUT			"				GND	"	"	GND	"	B to 4	"	"	"	
			"	156 & 157					OUT			"				5.0 V	"	"	GND	"	B to 5	"	"	"	
			"	158 & 159						OUT	OUT	"				5.0 V	"	"	5.0 V	"	B to 6	"	"	"	
			"	160 & 161	OUT		OUT					"				GND	GND	"	GND	"	B to 0	"	46	"	
			"	162 & 163		OUT						"				GND	5.0 V	"	GND	"	B to 1	"	"	"	
			"	164 & 165			OUT					"				GND	5.0 V	"	5.0 V	"	B to 2	"	"	"	
			"	166 & 167								"		OUT		5.0 V	5.0 V	"	GND	"	B to 8	"	"	"	
			"	168 & 169								"			OUT	5.0 V	IN	5.0 V	GND	"	C to 9	"	39	"	
			"	170 & 171								"				GND	"	5.0 V	GND	"	C to 1	"	46	"	
			"	172 & 173			OUT					"				GND	"	GND	5.0 V	"	C to 3	"	"	"	
			"	174 & 175				OUT				"				GND	"	"	GND	"	C to 4	"	"	"	
			"	176 & 177						OUT	OUT	"				5.0 V	"	"	GND	"	C to 5	"	"	"	
			"	178 & 179							OUT	OUT	"			5.0 V	"	"	5.0 V	"	C to 6	"	"	"	
			"	180 & 181								"		OUT		5.0 V	"	5.0 V	5.0 V	"	C to 7	"	"	"	
			"	182 & 183			OUT					"				IN	5.0 V	5.0 V	GND	"	D to 1	"	39	"	
			"	184 & 185				OUT				"				"	"	5.0 V	5.0 V	"	D to 2	"	39	"	
			"	186 & 187					OUT			"				"	"	GND	5.0 V	"	D to 4	"	39	"	
			"	188 & 189						OUT	OUT	"				"	"	GND	GND	"	D to 5	"	46	"	
			"	190 & 191								OUT	OUT	"		"	"	GND	5.0 V	"	D to 6	"	"	"	
			"	192 & 193									OUT			"	"	5.0 V	5.0 V	"	D to 7	"	"	"	
			"	194 & 195											OUT		"	GND	5.0 V	GND	"	D to 9	"	"	"
			11	Same tests, terminal conditions, and limits as subgroup 10, except T _C = -55°C.																					

NOTE: Output voltages shall be either: (a) H = 2.4 V minimum and L = 0.4 V maximum when using a high speed checker double comparator, or (b) H ≥ 1.5 V and L ≤ 1.5 V when using a high speed checker single comparator.

TABLE III. Group A inspection for device type 04 and 05.
Terminal conditions (pins not designated may be high ≥ 2.4 V or low ≤ 0.8 V; or open).

Subgroup	Symbol	MIL-STD-883 method	Cases E, F Test no.	1	2	3	4	5	6	7	8	9	10	11	12	13	14	15	16	Measured terminal	Limits		Unit
				0	1	2	3	4	5	6	GND	7	8	9	D	C	B	A	V _{CC}		Min	Max	
1 T _C = 25°C	V _{OL}	3007	1	80 mA							GND				0.8 V	0.8 V	0.8 V	0.8 V	4.5 V	0		0.9	V
		"	2		mA						"				"	"	0.8 V	2.0 V	"	1		"	"
		"	3			80 mA					"				"	"	2.0 V	0.8 V	"	2		"	"
		"	4	80			80 mA				"				"	"	2.0 V	2.0 V	"	3		"	"
		"	5					80 mA			"				"	2.0 V	0.8 V	0.8 V	"	4		"	"
		"	6						80 mA		"				"	"	0.8 V	2.0 V	"	5		"	"
		"	7							80 mA	"				"	"	2.0 V	0.8 V	"	6		"	"
		"	8								"	80 mA			"	"	2.0 V	2.0 V	"	7		"	"
		"	9								"		80 mA		"	"	0.8 V	0.8 V	"	8		"	"
		"	10								"			80 mA	2.0 V	0.8 V	0.8 V	2.0 V	"	9		"	"
V	OL2	3007	11	20 mA	20 mA						"				0.8 V	0.8 V	0.8 V	0.8 V	"	0		0.4 V	V
		"	12								"				"	"	0.8 V	2.0 V	"	1		"	"
		"	13			20 mA					"				"	"	2.0 V	0.8 V	"	2		"	"
		"	14				20 mA				"				"	"	2.0 V	2.0 V	"	3		"	"
		"	15					20 mA			"				"	2.0 V	0.8 V	0.8 V	"	4		"	"
		"	16						20 mA		"				"	"	0.8 V	2.0 V	"	5		"	"
		"	17							20 mA	"				"	"	2.0 V	0.8 V	"	6		"	"
		"	18								"	20 mA			"	"	2.0 V	2.0 V	"	7		"	"
		"	19								"		20 mA		"	"	0.8 V	0.8 V	"	8		"	"
		"	20								"			20 mA	2.0 V	0.8 V	0.8 V	2.0 V	"	9		"	"
I 1	CEX		21	Y							"				2.0 V	2.0 V	2.0 V	2.0 V	"	0		250	μA
			22		Y						"				"	"	"	"	"	1		"	"
			23			Y					"				"	"	"	"	"	2		"	"
			24				Y				"				"	"	"	"	"	3		"	"
			25					Y			"				"	"	"	"	"	4		"	"
			26						Y		"				"	"	"	"	"	5		"	"
			27							Y	"				"	"	"	"	"	6		"	"
			28								"	Y			"	"	"	"	"	7		"	"
			29								"		Y		"	"	"	"	"	8		"	"
			30								"			Y	"	"	"	"	"	9		"	"
V	IC		31								"						-12 mA	-12 mA	"	A		-1.5	V
			32								"								"	B		"	"
			33								"								"	C		"	"
			34								"				-12 mA	-12 mA	-12 mA		"	D		"	"
I	IL	3009	35								"				5.5 V	5.5 V	5.5 V	0.4 V	5.5 V	A	-0.7	-1.6	mA
		"	36								"				"	5.5 V	0.4 V	5.5 V	"	B		"	"
		"	37								"				"	0.4 V	5.5 V	"	"	C		"	"
		"	38								"				0.4 V	5.5 V	5.5 V	"	"	D		"	"
I	IH1	3010	39								"				GND	GND	GND	2.4 V	"	A		40	μA
		"	40								"				"	GND	2.4 V	GND	"	B		"	"
		"	41								"				"	2.4 V	GND	"	"	C		"	"
		"	42								"				2.4 V	GND	"	"	"	D		"	"
I	IH2	3010	43								"				GND	"	"	5.5 V	"	A		100	μA
		"	44								"				"	"	GND	"	"	B		"	"
		"	45								"				"	5.5 V	GND	"	"	C		"	"
		"	46								"				5.5 V	GND	GND	"	"	D		"	"
	CC	3005	47								"				GND	GND	GND	GND	"	V _{CC}		62	mA
2	Same tests, terminal conditions, and limits as subgroup 1, except T _C = +125°C and V _{IC} tests are omitted.																						
3	Same tests, terminal conditions, and limits as subgroup 1, except T _C = -55°C and V _{IC} tests are omitted.																						

See footnotes at end of device types 04 and 05.

TABLE III. Group A inspection for device type 04 and 05.
Terminal conditions (pins not designated may be high ≥ 2.4 V or low ≤ 0.8 V; or open).

Subgroup	Symbol	MIL-STD-883 method	Cases E, F	1	2	3	4	5	6	7	8	9	10	11	12	13	14	15	16	Measured terminal	Limits		Unit																																																																																																																																																																																																																																																																																																																					
			Test no.	0	1	2	3	4	5	6	GND	7	8	9	D	C	B	A	V _{CC}		Min	Max																																																																																																																																																																																																																																																																																																																						
7 T _C = 25°C	Truth table test		48	L	H	H	H	H	H	H	GND	H	H	H	GND	GND	GND	GND	5.0 V	5.0 V	2/																																																																																																																																																																																																																																																																																																																							
			49	H	L	H	"	"	"	"	"	"	"	"	"	"	"	GND	5.0 V	"																																																																																																																																																																																																																																																																																																																								
			50	"	H	L	"	"	"	"	"	"	"	"	"	"	"	5.0 V	GND	"																																																																																																																																																																																																																																																																																																																								
			51	"	"	H	L	"	"	"	"	"	"	"	"	"	"	5.0 V	5.0 V	"																																																																																																																																																																																																																																																																																																																								
			52	"	"	"	H	L	"	"	"	"	"	"	"	"	5.0 V	GND	GND	"																																																																																																																																																																																																																																																																																																																								
			53	"	"	"	"	L	L	"	"	"	"	"	"	"	"	GND	5.0 V	"																																																																																																																																																																																																																																																																																																																								
			54	"	"	"	"	"	H	L	"	"	"	"	"	"	"	5.0 V	GND	"																																																																																																																																																																																																																																																																																																																								
			55	"	"	"	"	"	"	"	H	"	"	"	"	"	"	5.0 V	5.0 V	"																																																																																																																																																																																																																																																																																																																								
			56	"	"	"	"	"	"	"	"	"	L	L	"	5.0 V	GND	GND	"																																																																																																																																																																																																																																																																																																																									
			57	"	"	"	"	"	"	"	"	"	"	H	L	"	"	GND	5.0 V	"																																																																																																																																																																																																																																																																																																																								
			58	"	"	"	"	"	"	"	"	"	"	"	H	"	"	5.0 V	GND	"																																																																																																																																																																																																																																																																																																																								
			59	"	"	"	"	"	"	"	"	"	"	"	"	"	"	5.0 V	5.0 V	"																																																																																																																																																																																																																																																																																																																								
			60	"	"	"	"	"	"	"	"	"	"	"	"	"	5.0 V	GND	GND	"																																																																																																																																																																																																																																																																																																																								
			61	"	"	"	"	"	"	"	"	"	"	"	"	"	"	GND	5.0 V	"																																																																																																																																																																																																																																																																																																																								
			62	"	"	"	"	"	"	"	"	"	"	"	"	"	"	5.0 V	GND	"																																																																																																																																																																																																																																																																																																																								
			63	"	"	"	"	"	"	"	"	"	"	"	"	"	"	5.0 V	5.0 V	"																																																																																																																																																																																																																																																																																																																								
			8	Truth table test		64 thru 79	Same tests as subgroup 7, except T _C = +125°C.																																																																																																																																																																																																																																																																																																																																					
80 thru 95	Same tests as subgroup 7, except T _C = -55°C.																																																																																																																																																																																																																																																																																																																																											
9 T _C = 25°C	t _{PHL} t _{PLH}	3003 (Fig. 5)	96 & 97	OUT	OUT	OUT	OUT	OUT	OUT	OUT	OUT	OUT	OUT	OUT	OUT	OUT	OUT	OUT	OUT	OUT	OUT	OUT	ns																																																																																																																																																																																																																																																																																																																					
			98 & 99																					OUT	OUT	OUT	OUT	OUT	OUT	OUT	OUT	OUT	OUT	OUT	OUT	OUT	OUT	OUT	OUT	OUT	OUT	OUT	OUT	OUT	OUT	OUT	OUT	OUT	OUT	OUT	OUT	OUT	OUT	OUT	OUT	OUT	OUT	OUT	OUT	OUT	OUT	OUT	OUT	OUT	OUT	OUT	OUT	OUT	OUT	OUT	OUT	OUT	OUT	OUT	OUT	OUT	OUT	OUT	OUT	OUT	OUT	OUT	OUT	OUT	OUT	OUT	OUT	OUT	OUT	OUT	OUT	OUT	OUT	OUT	OUT	OUT	OUT	OUT	OUT	OUT	OUT	OUT	OUT	OUT	OUT	OUT	OUT	OUT	OUT	OUT	OUT	OUT	OUT	OUT	OUT	OUT	OUT	OUT	OUT	OUT	OUT	OUT	OUT	OUT	OUT	OUT	OUT	OUT	OUT	OUT	OUT	OUT	OUT	OUT	OUT	OUT	OUT	OUT	OUT	OUT	OUT	OUT	OUT	OUT	OUT	OUT	OUT	OUT	OUT	OUT	OUT	OUT	OUT	OUT	OUT	OUT	OUT	OUT	OUT	OUT	OUT	OUT	OUT	OUT	OUT	OUT	OUT	OUT	OUT	OUT	OUT	OUT	OUT	OUT	OUT	OUT	OUT	OUT	OUT	OUT	OUT	OUT	OUT	OUT	OUT	OUT	OUT	OUT	OUT	OUT	OUT	OUT	OUT	OUT	OUT	OUT	OUT	OUT	OUT	OUT	OUT	OUT	OUT	OUT	OUT	OUT	OUT	OUT	OUT	OUT	OUT	OUT	OUT	OUT	OUT	OUT	OUT	OUT	OUT	OUT	OUT	OUT	OUT	OUT	OUT	OUT	OUT	OUT	OUT	OUT	OUT	OUT	OUT	OUT	OUT	OUT	OUT	OUT	OUT	OUT	OUT	OUT	OUT	OUT	OUT	OUT	OUT	OUT	OUT	OUT	OUT	OUT	OUT	OUT	OUT	OUT	OUT	OUT	OUT	OUT	OUT	OUT	OUT	OUT	OUT	OUT	OUT	OUT	OUT	OUT	OUT	OUT	OUT	OUT	OUT	OUT	OUT	OUT	OUT	OUT	OUT	OUT	OUT	OUT	OUT	OUT	OUT	OUT	OUT	OUT	OUT	OUT	OUT	OUT	OUT	OUT	OUT	OUT	OUT	OUT	OUT	OUT	OUT	OUT	OUT	OUT	OUT	OUT	OUT	OUT	OUT	OUT	OUT	OUT	OUT	OUT	OUT	OUT	OUT	OUT	OUT	OUT	OUT	OUT	OUT	OUT	OUT	OUT	OUT	OUT	OUT	OUT

TABLE III. Group A inspection for device type 04 and 05.
Terminal conditions (pins not designated may be high ≥ 2.4 V or low ≤ 0.8 V; or open).

Subgroup	Symbol	MIL-STD-883 method	Cases E, F	1	2	3	4	5	6	7	8	9	10	11	12	13	14	15	16	Measured terminal	Limits		Unit												
			Test no.	0	1	2	3	4	5	6	GND	7	8	9	D	C	B	A	V _{CC}		Min	Max													
10 T _C = 125°C	t _{PHL} t _{PLH}	3003 (Fig. 5)	140 & 141	OUT	OUT				OUT		GND		OUT		GND	GND	GND	IN	5.0 V	A to 0	5	73	ns												
			142 & 143	"							"				"	"	"	"	"	"	"	"	"	"	"	"	"	"	"	"	"				
			144 & 145	"							"				"	"	"	"	"	"	"	"	"	"	"	"	"	"	"	"	"	"			
			146 & 147	"							"				"	"	"	"	"	"	"	"	"	"	"	"	"	"	"	"	"	"			
			148 & 149	"	OUT								GND				GND	IN	5.0 V	"	B to 1	"	"	"	"										
			150 & 151	"									GND				IN	GND	"	"	"	"	"	"	"	"	"	"	"	"	"	"			
			152 & 153	"									"				5.0 V	IN	GND	"	"	"	"	"	"	"	"	"	"	"	"	"	"	"	
			154 & 155	"									"				IN	5.0 V	GND	"	"	"	"	"	"	"	"	"	"	"	"	"	"	"	
			156 & 157	"	OUT								"				"	5.0 V	5.0 V	"	C to 2	"	"	"	"	"									
			158 & 159	"									"				"	GND	GND	"	"	"	"	"	"	"	"	"	"	"	"	"	"	"	
			160 & 161	"									"				"	GND	5.0 V	"	"	"	"	"	"	"	"	"	"	"	"	"	"	"	"
			162 & 163	"									"				"	5.0 V	GND	"	"	"	"	"	"	"	"	"	"	"	"	"	"	"	"
			164 & 165	"									"				"	5.0 V	5.0 V	"	C to 7	"	"	"	"	"									
			166 & 167	"									"				GND	GND	"	"	"	"	"	"	"	"	"	"	"	"	"	"	"	"	
			168 & 169	"									"				GND	5.0 V	"	"	"	"	"	"	"	"	"	"	"	"	"	"	"	"	"
			170 & 171	"									"				IN	5.0 V	"	"	"	"	"	"	"	"	"	"	"	"	"	"	"	"	"
			172 & 173	"	OUT								"				"	GND	5.0 V	5.0 V	"	D to 3	"	"	"	"	"								
			174 & 175	"									"				5.0 V	GND	GND	"	"	"	"	"	"	"	"	"	"	"	"	"	"	"	"
			176 & 177	"									"				"	GND	5.0 V	"	"	"	"	"	"	"	"	"	"	"	"	"	"	"	"
			178 & 179	"									"				"	5.0 V	GND	"	"	"	"	"	"	"	"	"	"	"	"	"	"	"	"
			180 & 181	"												OUT			GND	GND	GND	5.0 V		D to 8	"	"	"	"	"						
			182 & 183	"																				"	"	"	"	"	"	"	"	"	"	"	"
11	Same tests, terminal conditions, and limits as subgroup 10, except T _C = -55°C.																																		

1/ Y = 30 volts for device type 04 and 15 volts for device type 05.

2/ Output voltages shall be either:

- (a) H = 2.4 V minimum and L = 0.4 V maximum when using a high speed checker double comparator, or
(b) H ≥ 1.5 V and L ≤ 1.5 V when using a high speed checker single comparator.

TABLE III. Group A inspection for device type 06 and 07.

See footnotes at end of device types 06 and 07.

TABLE III. Group A inspection for device type 06 and 07.
Terminal conditions (pins not designated may be high ≥ 2.4 V or low ≤ 0.8 V; or open).

Subgroup	Symbol	MIL-STD-883 method	Cases E, F	1	2	3	4	5	6	7	8	9	10	11	12	13	14	15	16	Measured terminal	Limits		Unit
			Test no.	IN B	IN C	LT	RBO	RBI	IN D	IN A	GND	OUT E	OUT D	OUT C	OUT B	OUT A	OUT G	OUT F	V _{CC}		Min	Max	
7 T _C = 25°C	Truth table test		44	GND	GND	5.0 V		5.0 V	GND	GND	GND	L	L	L	L	L	H	L	5.0 V	3/			
			45	GND	"	"		X	"	"	5.0 V	"	H	H	L	"	H	H	"				
			46	5.0 V	"	"		"	"	"	GND	"	L	L	H	"	L	L	"				
			47	5.0 V	"	"		"	"	"	5.0 V	"	H	L	L	"	L	"	H				"
			48	GND	5.0 V	"		"	"	"	GND	"	H	H	"	"	H	"	L				"
			49	GND	"	"		"	"	"	5.0 V	"	H	L	"	"	L	"	L				"
			50	5.0 V	"	"		"	"	"	GND	"	L	L	"	"	H	"	L				"
			51	5.0 V	"	"		"	"	"	5.0 V	"	H	H	"	"	L	H	H				"
			52	GND	GND	"		"	"	5.0 V	GND	"	L	L	"	"	L	L	L				"
			53	GND	"	"		"	"	"	5.0 V	"	H	H	"	"	L	L	L				"
			54	5.0 V	"	"		"	"	"	GND	"	L	L	H	"	H	"	H				"
			55	5.0 V	"	"		"	"	"	5.0 V	"	H	L	L	"	H	"	H				"
			56	GND	5.0 V	"		"	"	"	GND	"	H	H	H	"	H	"	L				"
			57	GND	"	"		"	"	"	5.0 V	"	H	L	L	"	L	"	L				"
			58	5.0 V	"	"		"	"	"	GND	"	L	L	"	"	H	"	L				"
			59	5.0 V	"	"		"	"	"	5.0 V	"	H	H	"	"	"	H	H				"
			60	X	X	X	GND	X	X	X	"	H	H	"	"	"	"	H	H				"
			61	GND	GND	5.0 V	L	GND	GND	GND	"	H	H	"	"	"	"	H	H				"
			62	X	X	GND		X	X	X	"	L	L	L	L	L	L	L	L				"
8	Truth table test		63 - 81	Same tests as subgroup 7, except T _C = 125°C.																			
			82 -100	Same tests as subgroup 7, except T _C = -55°C.																			
9 T _C = 25°C	t _{PHL} t _{PLH}	3003 (Fig. 6)	101 & 102	GND	GND	5.0 V		5.0 V	GND	IN	GND								5.0 V	IN A to A	8	104	ns
			103 & 104	GND	5.0 V	"		"	5.0 V	"	"								"	IN A to A	"	"	"
			105 & 106	5.0 V	"	"		"	GND	"	"								"	IN A to A	"	"	"
			107 & 108	GND	"	"		"	"	"	"								"	IN A to B	"	"	"
			109 & 110	5.0 V	"	"		"	"	"	"								"	IN A to B	"	"	"
			111 & 112	5.0 V	GND	"		"	"	"	"			OUT					"	IN A to C	"	"	"
			113 & 114	GND	GND	"		"	"	"	"			OUT					"	IN A to D	"	"	"
			115 & 116	GND	5.0 V	"		"	"	"	"			OUT					"	IN A to D	"	"	"
			117 & 118	5.0 V	5.0 V	"		"	"	"	"			OUT					"	IN A to D	"	"	"
			119 & 120	GND	GND	"		"	"	"	"			OUT					"	IN A to E	"	"	"
			121 & 122	5.0 V	GND	"		"	"	"	"			OUT					"	IN A to E	"	"	"
			123 & 124	GND	GND	"		"	"	"	"								"	IN A to F	"	"	"
			125 & 126	5.0 V	5.0 V	"		"	5.0 V	"	"								"	IN A to F	"	"	"
			127 & 128	5.0 V	5.0 V	"		"	5.0 V	"	"								"	IN A to G	"	"	"
			129 & 130	GND	GND	"	OUT	GND	GND	"	"								"	IN A to RBO	"	"	"
			131 & 132	IN	GND	"		5.0 V	5.0 V	GND	"								"	IN B to A	"	"	"
			133 & 134	"	GND	"		"	GND	5.0 V	"								"	IN B to A	"	"	"
			135 & 136	"	5.0 V	"		"	GND	GND	"								"	IN B to B	"	"	"
			137 & 138	"	GND	"		"	5.0 V	GND	"								"	IN B to B	"	"	"
			139 & 140	"	5.0 V	"		"	GND	5.0 V	"								"	IN B to B	"	"	"
			141 & 142	"	GND	"		"	5.0 V	5.0 V	"								"	IN B to B	"	"	"
			143 & 144	"	GND	"		"	GND	GND	"			OUT					"	IN B to C	"	"	"
			145 & 146	"	GND	"		"	"	5.0 V	"								"	IN B to D	"	"	"
			147 & 148	"	5.0 V	"		"	"	GND	"			OUT					"	IN B to D	"	"	"
			149 & 150	"	5.0 V	"		"	"	GND	"			OUT					"	IN B to E	"	"	"
			151 & 152	"	5.0 V	"		"	"	5.0 V	"								"	IN B to F	"	"	"
			153 & 154	"	GND	"		"	"	GND	"								"	IN B to F	"	"	"
			155 & 156	"	GND	"		"	5.0 V	"	"								"	IN B to F	"	"	"
			157 & 158	"	GND	"		"	GND	"	"								"	IN B to G	"	"	"
			159 & 160	GND	IN	"		"	5.0 V	"	"								"	IN C to A	"	"	"
			161 & 162	"	5.0 V	"		"	GND	"	"			OUT					"	IN C to C	"	"	"
			163 & 164	GND	"	"		"	5.0 V	5.0 V	"			OUT					"	IN C to C	"	"	"
			165 & 166	GND	"	"		"	GND	GND	"								"	IN C to D	"	"	"
			167 & 168	GND	"	"		"	GND	GND	"			OUT					"	IN C to E	"	"	"
			169 & 170	5.0 V	"	"		"	5.0 V	GND	"							OUT	"	IN C to F	"	"	"

See footnotes at end of device types 06 and 07.

TABLE III. Group A inspection for device type 06 and 07.
Terminal conditions (pins not designated may be high ≥ 2.4 V or low ≤ 0.8 V; or open).

Subgroup	Symbol	MIL-STD-883 method	Cases E, F	1	2	3	4	5	6	7	8	9	10	11	12	13	14	15	16	Measured terminal	Limits		Unit	
			Test no.	IN B	IN C	LT	RBO	RBI	IN D	IN A	GND	OUT E	OUT D	OUT C	OUT B	OUT A	OUT G	OUT F	V _{CC}		Min	Max		
9 T _C = 25°C	t _{PHL} t _{PLH}	3003 (Fig. 6)	171 & 172	GND	IN	5.0 V		5.0 V	GND	5.0 V	GND					OUT		OUT	5.0 V	IN C to F	8	104	ns	
			173 & 174	5.0 V	5.0 V	"		"	IN	5.0 V	"								"	IN D to A	"	"	"	
			175 & 176	GND	5.0 V	"		"	IN	GND	"			OUT					"	IN D to C	"	"	"	
			177 & 178	GND	"	"		"	IN	"	"								"	IN D to G	"	"	"	
			179 & 180	"	"	IN		GND	GND	"	"					OUT			"	LT to A	"	"	"	
			181 & 182	"	"	IN	OUT	GND	"	"	"								"	LT to RBO	"	"	"	
			183 & 184	"	"	5.0 V	IN	5.0 V	"	"	"					OUT			"	RBO to A	"	"	"	
			185 & 186	"	"	"	"	IN	"	"	"					OUT			"	RBI to A	"	"	"	
			187 & 188	"	"	"	OUT	IN	"	"	"								"	RBI to RBO	"	"	"	
			10 T _C = 125°C	t _{PHL} t _{PLH}	3003 (Fig. 6)	189 & 190	"	"	"		5.0 V		IN	"					OUT			"	IN A to A	8
191 & 192	"	5.0 V				"		"	5.0 V	"	"								"	IN A to A	"	"	"	
193 & 194	5.0 V	"				"		"	GND	"	"								"	IN A to A	"	"	"	
195 & 196	GND	"				"		"	"	"	"								"	IN A to B	"	"	"	
197 & 198	5.0 V	"				"		"	"	"	"								"	IN A to B	"	"	"	
199 & 200	5.0 V	GND				"		"	"	"	"								"	IN A to C	"	"	"	
201 & 202	GND	GND				"		"	"	"	"			OUT		OUT			"	IN A to D	"	"	"	
203 & 204	GND	5.0 V				"		"	"	"	"			OUT					"	IN A to D	"	"	"	
205 & 206	5.0 V	5.0 V				"		"	"	"	"			OUT					"	IN A to D	"	"	"	
207 & 208	GND	GND				"		"	"	"	"			OUT					"	IN A to E	"	"	"	
209 & 210	5.0 V	GND				"		"	"	"	"			OUT					"	IN A to E	"	"	"	
211 & 212	GND	GND				"		"	"	"	"								"	IN A to F	"	"	"	
213 & 214	5.0 V	5.0 V				"		"		5.0 V	"								"	IN A to F	"	"	"	
215 & 216	5.0 V	5.0 V				"		"		5.0 V	"							OUT	OUT	IN A to G	"	"	"	
217 & 218	GND	GND				"	OUT	GND	"	GND	"								"	IN A to RBO	"	"	"	
219 & 220	IN	"						5.0 V	"	5.0 V	"								"	IN B to A	"	"	"	
221 & 222	"	GND				"		"	"	GND	5.0 V	"							"	IN B to A	"	"	"	
223 & 224	"	5.0 V				"		"	"	GND	"	"							"	IN B to B	"	"	"	
225 & 226	"	GND				"		"	"	5.0 V	GND	"						OUT	OUT	IN B to B	"	"	"	
227 & 228	"	5.0 V				"		"	"	GND	5.0 V	"						OUT	OUT	IN B to B	"	"	"	
229 & 230	"	GND				"		"	"	5.0 V	5.0 V	"						OUT	OUT	IN B to B	"	"	"	
231 & 232	"	GND				"		"	"	"	GND	"					OUT			IN B to C	"	"	"	
233 & 234	"	GND				"		"	"	"	"	5.0 V	"				OUT			IN B to D	"	"	"	
235 & 236	"	5.0 V				"		"	"	GND	"	"					OUT			IN B to D	"	"	"	
237 & 238	"	5.0 V				"		"	"	"	"	GND				OUT				IN B to E	"	"	"	
239 & 240	"	5.0 V				"		"	"	"	5.0 V	"								IN B to F	"	"	"	
241 & 242	"	GND				"		"	"	"	GND	"							OUT	OUT	IN B to F	"	"	"
243 & 244	"	GND				"		"	"	"	"	5.0 V	"							IN B to F	"	"	"	
245 & 246	"	GND				"		"	"	"	GND	"							OUT	OUT	IN B to G	"	"	"
247 & 248	GND	IN				"		"	"	5.0 V	"	"						OUT		"	IN C to A	"	"	"
249 & 250	5.0 V	"				"		"	"	GND	"	"								"	IN C to C	"	"	"
251 & 252	GND	"				"		"	"	5.0 V	5.0 V	"					OUT			"	IN C to C	"	"	"
253 & 254	GND	"				"		"	"	GND	GND	"					OUT			"	IN C to D	"	"	"
255 & 256	GND	"				"		"	"	"	GND	GND	"				OUT			"	IN C to E	"	"	"
257 & 258	5.0 V	"				"		"	"	"	5.0 V	GND	"						OUT	OUT	IN C to F	"	"	"
259 & 260	GND	5.0 V				"		"	"	"	GND	5.0 V	"							"	IN C to F	"	"	"
261 & 262	5.0 V	5.0 V				"		"	"	"	IN	5.0 V	"							"	IN D to A	"	"	"
263 & 264	GND	5.0 V				"		"	"	"	IN	GND	"							"	IN D to C	"	"	"
265 & 266	"	GND				"		"	"	"	IN	"	"							"	IN D to G	"	"	"
267 & 268	"	"				IN		IN	IN	OUT	GND	"	"						OUT		LT to A	"	"	"
269 & 270	"	"				"		"	5.0 V	OUT	5.0 V	"	"						OUT		LT to RBO	"	"	"
271 & 272	"	"				"		"	"	IN	IN	"	"						OUT		RBO to A	"	"	"
273 & 274	"	"				"		"	"	OUT	IN	"	"						OUT		RBI to A	"	"	"
275 & 276	"	"	"		"	"	OUT	IN	"	"							"	RBI to RBO	"	"	"			
11	Same tests, terminal conditions, and limits as subgroup 10 except T _C = -55°C.																							

- 1/ X = Input may be high level or low level.
- 2/ Y = 30 volts for device type 05 and 15 volts for device type 07.
- 3/ Output voltages shall be either:
 - (a) H = 2.4 volts minimum and L = 0.4 volts minimum when using high speed checker double comparator, or
 - (b) H ≥ 1.5 volts and L ≤ 1.5 volts when using a high speed checker single comparator.
- 4/ CKT except C.

TABLE III. Group A inspection for device type 08.
Terminal conditions (pins not designated may be high ≥ 2.4 V or low ≤ 0.8 V; or open).

Subgroup	Symbol	MIL-STD-883 method	Cases E, F	1	2	3	4	5	6	7	8	9	10	11	12	13	14	15	16	Measured terminal	Limits		Unit	
			Test no.	IN B	IN C	LT	RBO	RBI	IN D	IN A	GND	OUT E	OUT D	OUT C	OUT B	OUT A	OUT G	OUT F	V _{CC}		Min	Max		
1 T _C = 25°C	V _{OH1} 1/	3006	1	X	X	0.8 V		X	X	X	GND	-0.4 mA	-0.4 mA						4.5 V	OUT E	2.4 V		V	
			2	"	"	"		"	"	"	"								"	OUT D	"		"	
			3	"	"	"		"	"	"	"			-0.4 mA					"	OUT C	"		"	
			4	"	"	"		"	"	"	"				-0.4 mA				"	OUT B	"		"	
			5	"	"	"		"	"	"	"					-0.4 mA			"	OUT A	"		"	
			6	"	"	"		"	"	"	"						-0.4 mA		"	OUT G	"		"	
			7	"	"	"		"	"	"	"							-0.4 mA	"	OUT F	"		"	
V V	OH2 OL1	3007	8	0.8 V	0.8 V	2.0 V	-2 mA	0.8 V	0.8 V	0.8 V	"								"	RBO			"	
			9	"	"	"		"	"	"	"	6.4 mA							"	OUT E		0.4	"	
			10	"	"	"		"	"	"	"		6.4 mA						"	OUT D	"		"	
			11	"	"	"		"	"	"	"			6.4 mA					"	OUT C	"		"	
			12	"	"	"		"	"	"	"				6.4 mA				"	OUT B	"		"	
			13	"	"	"		"	"	"	"					6.4 mA			"	OUT A	"		"	
			14	"	"	"		"	"	"	"						6.4 mA		"	OUT G	"		"	
V V	OL2 IC	3007	16	0.8 V	0.8 V	2.0 V	8 mA	0.8 V	0.8 V	0.8 V	"							6.4 mA	"	RBO		0.4	"	
			17	-12 mA	-12 mA		"			"									"	IN B		-1.5	"	
			18				"			"									"	IN C			"	
			19				-12 mA			"										"	RBO			"
			20					-12 mA		"										"	RBI			"
			21						-12 mA	"									"	"	IN D			"
			22							-12 mA	"									"	IN A			"
I	IL1	3009	23 2/	0.4 V	5.5 V	5.5 V		5.5 V	5.5 V	5.5 V	"							"	5.5 V	IN B	-0.7	-1.6	mA	
			23 CKT B	0.4 V	5.5 V	5.5 V		"	"	"	"								"	IN B	-0.4	-1.3	"	
			24 2/	5.5 V	0.4 V	5.5 V		"	"	"	"								"	IN C	-0.7	-1.6	"	
			24 CKT B	"	0.4 V	5.5 V		"	"	"	"								"	IN C	-0.4	-1.3	"	
			25 2/	"	5.5 V	0.4 V		"	"	"	"								"	LT	-0.7	-1.6	"	
			25 CKT B	"	"	0.4 V		"	"	"	"								"	LT	-0.4	-1.3	"	
			26 2/	"	"	5.5 V		0.4 V	"	"	"								"	RBI	-0.7	-1.6	"	
			26 CKT B	"	"	"		0.4 V	"	"	"								"	RBI	-0.4	-1.3	"	
			27 2/	"	"	"		5.5 V	0.4 V	"	"								"	IN D	-0.7	-1.6	V	
			27 CKT B	"	"	"		"	0.4 V	"	"								"	IN D	-0.4	-1.3	"	
			28 2/	"	"	"		"	5.5 V	0.4 V	0.4 V								"	IN A	-0.7	-1.6	"	
I I	IL2 IH1	3009 3010	29	"	"	"	0.4 V	5.5 V	5.5 V	5.5 V	"							"	"	RBO	-1.7	-4.2	mA	
			30	2.4 V	GND	GND		GND	GND	GND	"								"	IN B		40	μA	
			31	GND	2.4 V	GND		GND	GND	"	"								"	IN C			"	
			32	"	GND	2.4 V		GND	GND	"	"								"	LT			"	
			33	"	"	GND		2.4 V	"	"	"								"	RBI			"	
			34	"	"	GND		GND	2.4 V	"	"								"	IN D			"	
			35	"	"	GND		GND	GND	2.4 V	"								"	IN A			"	
I	IH2	3010	36	5.5 V	GND	GND		GND	GND	GND	"							"	"	IN B		100	μA	
			37	GND	5.5 V	GND		GND	GND	"	"								"	IN C			"	
			38	"	GND	5.5 V		GND	GND	"	"								"	LT			"	
			39	"	"	GND		5.5 V	"	"	"								"	RBI			"	
			40	"	"	"		GND	"	"	"								"	IN D			"	
			41	"	"	"		GND	GND	5.5 V	5.5 V								"	IN A			"	
			42	X	X	GND		X	X	X	"								"	OUT A		-4	mA	
I	OS	3011	43	"	"	"		"	"	"	"							"	"	OUT B			"	
			44	"	"	"		"	"	"	"								"	OUT C			"	
			45	"	"	"		"	"	"	"								"	OUT D			"	
			46	"	"	"		"	"	"	"								"	OUT E			"	
			47	"	"	"		"	"	"	"								"	OUT F			"	
			48	"	"	"		"	"	"	"								"	OUT G			"	
			49	"	"	"	GND	"	"	"	"								"	RBO			"	
CC	3005	50	"	"	"	"	"	"	"	"	"	"	"	"	"	"	"	V _{CC}		76	mA			
2	Same tests, terminal conditions, and limits as subgroup 1, except T _C = +125°C and V _{I C} tests are omitted.																							
3	Same tests, terminal conditions, and limits as subgroup 1, except T _C = -55°C and V _{I C} tests are omitted.																							

See footnotes at end of device types 08.

TABLE III. Group A inspection for device type 08.
Terminal conditions (pins not designated may be high ≥ 2.4 V or low ≤ 0.8 V; or open).

Subgroup	Symbol	MIL-STD-883 method	Cases E, F	1	2	3	4	5	6	7	8	9	10	11	12	13	14	15	16	Measured terminal	Limits		Unit
			Test no.	IN B	IN C	LT	RBO	RBI	IN D	IN A	GND	OUT E	OUT D	OUT C	OUT B	OUT A	OUT G	OUT F	V _{CC}		Min	Max	
7 T _C = 25°C	Truth table test		51	GND	GND	5.0 V		5.0 V	GND	GND	GND	H	H	H	H	H	L	H	5.0 V	3/			
			52	GND	"	"		X	"	"	"	L	L	H	"	L	L	"	"				
			53	5.0 V	"	"		"	"	GND	"	H	H	L	"	H	H	"	"				
			54	5.0 V	"	"		"	"	5.0 V	"	L	H	H	"	H	"	"	"				
			55	GND	5.0 V	"		"	"	GND	"	"	L	"	"	L	"	H	"				
			56	GND	"	"		"	"	5.0 V	"	"	H	"	L	L	"	"	"				
			57	5.0 V	"	"		"	"	GND	"	H	H	"	L	L	"	"	"				
			58	5.0 V	"	"		"	"	5.0 V	"	L	L	"	H	H	L	L	"				
			59	GND	GND	"		"	5.0 V	GND	"	H	H	"	"	"	H	H	"				
			60	GND	"	"		"	"	5.0 V	"	L	L	"	"	"	"	H	"				
			61	5.0 V	"	"		"	"	GND	"	H	H	L	L	L	"	L	"				
			62	5.0 V	"	"		"	"	5.0 V	"	L	H	H	L	"	"	L	"				
			63	GND	5.0 V	"		"	"	GND	"	"	L	L	"	H	"	"	"				
			64	GND	"	"		"	"	5.0 V	"	"	H	"	L	H	"	"	"				
			65	5.0 V	"	"		"	"	GND	"	H	H	"	"	L	"	"	"				
			66	5.0 V	"	"		"	"	5.0 V	"	L	L	"	"	"	L	L	"				
			67	X	X	X	GND L	X	X	X	"	"	"	"	"	"	"	"	"				"
			68	GND	GND	5.0 V		GND	GND	GND	"	"	"	"	"	"	"	"	"				"
			69	X	X	GND		X	X	X	"	H	H	H	H	H	H	H	"				"
8	Truth table test		70 - 89	Same tests as subgroup 7, except T _C = 125°C.																			
			90 - 109	Same tests as subgroup 7, except T _C = -55°C.																			
9 T _C = 25°C	t _{PHL} t _{PLH}	3003 (Fig. 7)	110 & 111	GND	GND	5.0 V		5.0 V	GND	IN	GND		OUT			OUT			5.0 V	IN A to A	8	104	ns
			112 & 113	"	"	"		"	"	"	"	"							"	IN A to D	"	"	"
			114 & 115	"	"	"		"	"	"	"	"							"	IN A to E	"	"	"
			116 & 117	"	"	"		"	"	"	"	"							"	IN A to F	"	"	"
			118 & 119	5.0 V	5.0 V	"		"	"	"	"	"							"	IN A to A	"	"	"
			120 & 121	GND	5.0 V	"		"	"	"	"	"							"	IN A to B	"	"	"
			122 & 123	5.0 V	5.0 V	"		"	"	"	"	"			OUT				"	IN A to D	"	"	"
			124 & 125	GND	GND	"	OUT	GND	"	"	"	"							"	IN A to RBO	"	"	"
			126 & 127	IN	"	"		5.0 V	"	GND	"			OUT					"	IN B to C	"	"	"
			128 & 129	"	"	"		"	"	"	"	"							"	IN B to F	"	"	"
			130 & 131	"	"	"		"	"	"	"	"							"	IN B to G	"	"	"
			132 & 133	"	"	"		"	5.0 V	"	"	"					OUT		"	IN B to A	"	"	"
			134 & 135	"	5.0 V	"		"	GND	5.0 V	"	"					OUT		"	IN B to F	"	"	"
			136 & 137	"	5.0 V	"		"	"	5.0 V	"	"					OUT		"	IN B to G	"	"	"
			138 & 139	"	5.0 V	"		"	"	GND	"	OUT							"	IN B to E	"	"	"
			140 & 141	"	IN	"		"	"	"	"	"		OUT					"	IN C to D	"	"	"
			142 & 143	5.0 V	IN	"		"	"	"	"	"		OUT			OUT		"	IN C to B	"	"	"
			144 & 145	"	GND	"		"	IN	"	"	"					OUT		"	IN D to A	"	"	"
			146 & 147	"	GND	"		"	IN	"	"	"					OUT		"	IN D to B	"	"	"
			148 & 149	GND	5.0 V	"		"	IN	"	"	"							"	IN D to C	"	"	"
			150 & 151	GND	GND	IN		GND	GND	"	"	"							"	LT to A	"	"	"
			152 & 153	X	X	"	IN	X	X	X	"	"					OUT		"	RBO to A	"	"	"
			154 & 155	GND	GND	5.0 V		IN	GND	GND	"	"					OUT		"	RBI to A	"	"	"

See footnotes at end of device types 08.

TABLE III. Group A inspection for device type 08.
Terminal conditions (pins not designated may be high ≥ 2.4 V or low ≤ 0.8 V; or open).

Subgroup	Symbol	MIL-STD-883 method	Cases E, F	1	2	3	4	5	6	7	8	9	10	11	12	13	14	15	16	Measured terminal	Limits		Unit																				
			Test no.	IN B	IN C	LT	RBO	RBI	IN D	IN A	GND	OUT E	OUT D	OUT C	OUT B	OUT A	OUT G	OUT F	V _{CC}		Min	Max																					
10 T _C = 125°C	t _{PHL} t _{PLH}	3003 (Fig. 7)	156 & 157	GND	GND	5.0 V	OUT	5.0 V	GND	IN	GND	OUT	OUT	OUT	OUT	OUT	OUT	OUT	OUT	5.0 V	IN A to A	8	144	ns																			
			158 & 159	"	"	"		"	"	"	"									"	"	"	"		"	"	"	"	"	"	"	"	"										
			160 & 161	"	"	"		"	"	"	"									"	"	"	"		"	"	"	"	"	"	"	"	"	"	"								
			162 & 163	"	"	"		"	"	"	"									"	"	"	"		"	"	"	"	"	"	"	"	"	"	"								
			164 & 165	5.0 V	5.0 V	"		"	"	"	"									"	"	"	"		"	"	"	"	"	"	"	"	"	"	"								
			166 & 167	GND	5.0 V	"		"	"	"	"									"	"	"	"		"	"	"	"	"	"	"	"	"	"	"								
			168 & 169	5.0 V	5.0 V	"		"	"	"	"									"	"	"	"		"	"	"	"	"	"	"	"	"	"	"								
			170 & 171	GND	GND	"		OUT	GND	"	"									"	"	"	"		"	"	"	"	"	"	"	"	"	"	"								
			172 & 173	IN	"	"			5.0 V	"	GND									"	"	"	"		"	"	"	"	"	"	"	"	"	"	"								
			174 & 175	"	"	"			"	"	"									"	"	"	"		"	"	"	"	"	"	"	"	"	"	"	"							
			176 & 177	"	"	"			"	"	"									"	"	"	"		"	"	"	"	"	"	"	"	"	"	"	"							
			178 & 179	"	"	"			"	"	"									5.0 V	"	"	"		"	"	"	"	"	"	"	"	"	"	"	"							
			180 & 181	"	5.0 V	"			"	"	"									GND	5.0 V	"	"		"	"	"	"	"	"	"	"	"	"	"	"							
			182 & 183	"	5.0 V	"			"	"	"									"	5.0 V	"	"		"	"	"	"	"	"	"	"	"	"	"	"							
			184 & 185	"	5.0 V	"			"	"	"									"	"	GND	"		OUT	OUT	OUT	OUT	OUT	OUT	OUT	"	"	"	"	"							
			186 & 187	"	IN	"			"	"	"									"	"	"	"									"	"	"	"	"	"	"	"	"	"	"	"
			188 & 189	5.0 V	IN	"			"	"	"									"	"	"	"									"	"	"	"	"	"	"	"	"	"	"	"
			190 & 191	"	GND	"			"	"	"									"	IN	"	"									"	"	"	"	"	"	"	"	"	"	"	"
			192 & 193	"	GND	"			"	"	"									"	"	"	"									"	"	"	"	"	"	"	"	"	"	"	"
			194 & 195	GND	5.0 V	"			"	"	"									IN	IN	"	"									"	"	"	"	"	"	"	"	"	"	"	"
			196 & 197	GND	GND	IN			IN	GND	"									GND	"	"	"									"	"	"	"	"	"	"	"	"	"	"	"
			198 & 199	X	X	GND				X	X									X	"	"	"									"	"	"	"	"	"	"	"	"	"	"	"
			200 & 201	GND	GND	5.0 V				"	"									"	"	"	"									"	"	"	"	"	"	"	"	"	"	"	"
11	Same tests, terminal conditions, and limits as subgroup 10 except T _C = -55°C.																																										

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- 1/ X = Input may be high level or low level.
 / CKT except B.
 2 3/ Output voltages shall be either:
 (a) H = 2.4 volts minimum and L = 0.4 volts minimum when using high speed checker double comparator, or
 (b) H ≥ 1.5 volts and L ≤ 1.5 volts when using a high speed checker single comparator.

TABLE III. Group A inspection for device type 09.
Terminal conditions (pins not designated may be high ≥ 2.0 V or low ≤ 0.8 V or open).

Subgroup	Symbol	MIL-STD-883 method	Cases A,B,C,D Test no.	1	2	3	4	5	6	7	8	9	10	11	12	13	14	Measured	Limits		Unit
				IN B	IN C	BI	IN D	IN A	OUT E	GND	OUT D	OUT C	OUT B	OUT A	OUT G	OUT F	V _{CC}		Min	Max	
1 T _C = 25°C	V _{OL} 1/	3007	1	X	X	0.8 V	X	X	10 mA	GND	10 mA	10 mA					4.5 V	E		0.4	V
		"	2	"	"	"	"	"		"	10 mA						"	D		"	"
		"	3	"	"	"	"	"		"		10 mA					"	C		"	"
		"	4	"	"	"	"	"		"			mA				"	B		"	"
		"	5	"	"	"	"	"		"				10 mA			"	A		"	"
		"	6	"	"	"	"	"		"		10			10 mA		"	G		"	"
		"	7	"	"	"	"	"		"						10 mA	"	F		"	"
	CEX		8	0.8 V	0.8 V	2.0 V	2.0 V	0.8 V	5.5 V	"	5.5 V	5.5 V	5.5 V	5.5 V	5.5 V	5.5 V	"	E		250	μA
			9	"	"	"	"	"		"							"	D		"	"
			10	"	"	"	"	"		"		5.5 V					"	C		"	"
			11	"	"	"	"	"		"			5.5 V	5.5 V			"	B		"	"
			12	"	"	"	"	"		"					5.5 V		"	A		"	"
			13	"	"	"	"	"		"						5.5 V	"	G		"	"
			14	"	"	"	"	"		"							"	F		"	"
	I _C		15	-12 mA				-12 mA		"							"	IN A		-1.5	"
			16		-12 mA					"							"	IN B		"	"
			17				-12 mA			"							"	IN C		"	"
			18							"							"	IN D		"	"
			19			-12 mA				"							"	BI		"	"
	I _L	3009	20 2/	5.5 V	5.5 V	5.5 V	5.5 V	0.4 V		"							5.5 V	IN A	-0.7	-1.6	mA
		"	20 CKT C	5.5 V	"	"	"	0.4 V		"							"	IN A	-0.4	-1.3	"
		"	21 2/	0.4 V	"	"	"	5.5 V		"							"	IN B	-0.7	-1.6	"
		"	21 CKT C	0.4 V	"	"	"			"							"	IN B	-0.4	-1.3	"
		"	22 2/	5.5 V	0.4 V	"	"	"		"							"	IN C	-0.7	-1.6	"
		"	22 CKT C	0.4 V	0.4 V	"	"	"		"							"	IN C	-0.4	-1.3	"
		"	23 2/	"	5.5 V	"	0.4 V	"		"							"	IN D	-0.7	-1.6	"
		"	23 CKT C	"	"	"	0.4 V	"		"							"	IN D	-0.4	-1.3	"
		"	24 2/	"	"	0.4 V	5.5 V	"		"							"	BI	-0.7	-1.6	"
		"	24 CKT C	"	"	0.4 V	5.5 V	"		"							"	BI	-0.4	-1.3	"
	I _{H1}	3010	25	GND	GND	GND	GND	2.4 V		"							"	IN A		40	μA
		"	26	2.4 V	GND	"	"	GND		"							"	IN B		"	"
		"	27	GND	2.4 V	"	"	"		"							"	IN C		"	"
		"	28	"	GND	"	2.4 V	"		"							"	IN D		"	"
		"	29	"	"	2.4 V	GND	"		"							"	BI		"	"
	I _{H2}	3010	30	"	"	GND	"	5.5 V		"							"	IN A		100	μA
		"	31	5.5 V	"	"	"	GND		"							"	IN B		"	"
		"	32	GND	5.5 V	"	"	"		"							"	IN C		"	"
		"	33	"	GND	"	5.5 V	"		"							"	IN D		"	"
		"	34	"	"	5.5 V	GND	"		"							"	BI		"	"
	CC	3005	35	GND	GND	GND	GND	GND		"							"	V _{CC}		47	mA
2	Same tests, terminal conditions, and limits as subgroup 1, except T _C = +125°C and V _{I C} tests are omitted.																				
3	Same tests, terminal conditions, and limits as subgroup 1, except T _C = -55°C and V _{I C} tests are omitted.																				

See footnotes at end of device type 09.

TABLE III. Group A inspection for device type 09 – Continued.
Terminal conditions (pins not designated may be high ≥ 2.0 V or low ≤ 0.8 V or open).

Subgroup	Symbol	MIL-STD-883 method	Cases A,B,C,D	1	2	3	4	5	6	7	8	9	10	11	12	13	14	Measured terminal	Limits		Unit
			Test no.	IN B	IN C	BI	IN D	IN A	OUT E	GND	OUT D	OUT C	OUT B	OUT A	OUT G	OUT F	V _{CC}		Min	Max	
7 T _C = 25°C	Truth table		36 37 38 39 40 41 42 43 44 45 46 47 48 49 50 51 52	GND " 5.0 V 5.0 V GND GND 5.0 V 5.0 V GND GND 5.0 V 5.0 V GND GND 5.0 V 5.0 V GND GND 5.0 V 5.0 V X	GND " " " 5.0 V " " GND GND " " 5.0 V " 5.0 V " 5.0 V " X	 5.0 V GND GND X	GND 5.0 V GND 5.0 V 5.0 V GND 5.0 V GND 5.0 V 5.0 V GND 5.0 V GND 5.0 V GND 5.0 V GND 5.0 V X	GND 5.0 V GND 5.0 V 5.0 V GND 5.0 V GND 5.0 V 5.0 V GND 5.0 V GND 5.0 V GND 5.0 V GND 5.0 V X	H L H L " H L H L H L H L H L H L L	GND " " H " " " " " " " " " " " " " " " " "	H L H H " H " H L H L H L H L H L L	H H L H " " L L L L L L L L L L L L L	H L H " H " H " " " " " " " " " " " " "	L L H " " L L H L L L L L L L L L L L	H L " " H " H " " " " " " " " " " " " " "	5.5 V " " " " " " " " " " " " " " " " " " "		<u>3</u> /			
8	Truth table test		53 to 69	Same tests as subgroup 7, except T _C = 125°C.																	
			70 to 76	Same tests as subgroup 7, except T _C = -55°C.																	
9 T _C = 25°C	t _{PHL} t _{PLH}	3003 (Fig 8)	77 & 78 79 & 80 81 & 82 83 & 84 85 & 86 87 & 88 89 & 90 91 & 92 93 & 94 95 & 96 97 & 98 99 & 100 101 & 102 103 & 104 105 & 106 107 & 108 109 & 110 111 & 112 113 & 114 115 & 116	GND " " " 5.0 V GND 5.0 V IN " " " " " GND 5.0 V 5.0 V IN 5.0 V GND 5.0 V GND 5.0 V GND 5.0 V GND GND	GND " " " 5.0 V 5.0 V 5.0 V GND " " 5.0 V 5.0 V 5.0 V IN IN GND GND GND GND GND GND GND GND	5.0 V " IN	GND " " " " " " " " " 5.0 V " " " " " IN " " " " IN IN IN GND	IN " " " " " " GND 5.0 V GND 5.0 V GND 5.0 V GND GND GND GND GND GND GND GND GND GND	 <												

See notes at end of device type 09.

TABLE III. Group A inspection for device type 09 – Continued.
Terminal conditions (pins not designated may be high ≥ 2.0 V or low ≤ 0.8 V or open).

Subgroup	Symbol	MIL-STD-883 method	Cases A,B,C,D	1	2	3	4	5	6	7	8	9	10	11	12	13	14	Measured	Limits		Unit		
				Test no.	IN B	IN C	BI	IN D	IN A	OUT E	GND	OUT D	OUT C	OUT B	OUT A	OUT G	OUT F		V _{CC}	Min		Max	
10 T _c = 125°C	t _{PHL} t _{PLH}	3003 (Fig 8)	117 & 118	GND	GND	5.0 V	GND	IN		GND					OUT			5.0 V	IN A to A	8	144	ns	
			119 & 120	"	"	"	"	"					OUT					"	terminal	IN A to D	"	"	"
			121 & 122	"	"	"	"	"		OUT	"								"	IN A to E	"	"	"
			123 & 124	"	"	"	"	"		"	"								"	IN A to F	"	"	"
			125 & 126	5.0 V	5.0 V	"	"	"	"	"	"				OUT				"	IN A to A	"	"	"
			127 & 128	GND	5.0 V	"	"	"			"								"	IN A to B	"	"	"
			129 & 130	5.0 V	5.0 V	"	"	"			"		OUT						"	IN A to D	"	"	"
			131 & 132	IN	GND	"	"	GND			"		OUT						"	IN A to C	"	"	"
			133 & 134	"	"	"	"	"			"								"	IN B to F	"	"	"
			135 & 136	"	"	"	"	"			"								"	IN B to G	"	"	"
			137 & 138	"	"	"	"	5.0 V			"					OUT			"	IN B to A	"	"	"
			139 & 140	"	5.0 V	"	GND	5.0 V			"								"	IN B to F	"	"	"
			141 & 142	"	5.0 V	"	"	GND		OUT	"								"	IN B to E	"	"	"
			143 & 144	"	5.0 V	"	"	5.0 V		"	"								"	IN B to G	"	"	"
			145 & 146	GND	IN	"	"	GND			"		OUT						"	IN C to D	"	"	"
			147 & 148	5.0 V	IN	"	"	GND			"								"	IN C to B	"	"	"
			149 & 150	GND	GND	"	IN	GND			"					OUT			"	IN D to G	"	"	"
			151 & 152	5.0 V	GND	"	IN	5.0 V			"								"	IN D to B	"	"	"
			153 & 154	GND	5.0 V	"	IN	GND			"				OUT				"	IN D to C	"	"	"
			155 & 156	GND	GND	IN	GND	GND		"						OUT			"	BI to A	"	"	"
11	Same tests, terminal conditions and limits as for subgroup 10, except T _c = -55°C.																						

1/ X = Input may be high level or low level.

2/ CKT except B.

3/ Output voltages shall be either:

(a) H = 2.4 volts minimum and L = 0.4 volts minimum when using high speed checker double comparator, or

(b) H ≥ 1.5 volts and L ≤ 1.5 volts when using a high speed checker single comparator.

5. PACKAGING

5.1 Packaging requirements. For acquisition purposes, the packaging requirements shall be as specified in the contract or order (see 6.2). When packaging of materiel is to be performed by DoD or in-house contractor personnel, these personnel need to contact the responsible packaging activity to ascertain packaging requirements. Packaging requirements are maintained by the Inventory Control Point's packaging activity within the Military Service or Defense Agency, or within the military service's system command. Packaging data retrieval is available from the managing Military Department's or Defense Agency's automated packaging files, CD-ROM products, or by contacting the responsible packaging activity.

6. NOTES

(This section contains information of a general or explanatory nature that may be helpful, but it is not mandatory)

6.1 Intended use. Microcircuits conforming to this specification are intended for original equipment design applications and logistic support of existing equipment.

6.2 Acquisition requirements. Acquisition documents should specify the following:

- a. Title, number, and date of the specification.
- b. PIN and compliance identifier, if applicable (see 1.2).
- c. Requirements for delivery of one copy of the conformance inspection data pertinent to the device inspection lot to be supplied with each shipment by the device manufacturer, if applicable.
- d. Requirements for certificate of compliance, if applicable.
- e. Requirements for notification of change of product or process to contracting activity in addition to notification to the qualifying activity, if applicable.
- f. Requirements for failure analysis (including required test condition of method 5003 of MIL-STD-883), corrective action, and reporting of results, if applicable.
- g. Requirements for product assurance options.
- h. Requirements for special carriers, lead lengths, or lead forming, if applicable. These requirements should not affect the part number. Unless otherwise specified, these requirements will not apply to direct purchase by or direct shipment to the Government.
- i. Requirements for "JAN" marking.
- j. Packaging requirements (see 5.1).

6.3 Qualification. With respect to products requiring qualification, awards will be made only for products which are, at the time of award of contract, qualified for inclusion in Qualified Manufacturers List QML-38535 whether or not such products have actually been so listed by that date. The attention of the contractors is called to these requirements, and manufacturers are urged to arrange to have the products that they propose to offer to the Federal Government tested for qualification in order that they may be eligible to be awarded contracts or purchase orders for the products covered by this specification. Information pertaining to qualification of products may be obtained from DSCC-VQ, 3990 E. Broad Street, Columbus, Ohio 43123-1199.

6.4 Superseding information. The requirements of MIL-M-38510 have been superseded to take advantage of the available Qualified Manufacturer Listing (QML) system provided by MIL-PRF-38535. Previous references to MIL-M-38510 in this document have been replaced by appropriate references to MIL-PRF-38535. All technical requirements now consist of this specification and MIL-PRF-38535. The MIL-M-38510 specification sheet number and PIN have been retained to avoid adversely impacting existing government logistics systems and contractor's parts lists.

6.5 Abbreviations, symbols, and definitions. The abbreviations, symbols, and definitions used herein are defined in MIL-PRF-38535, MIL-HDBK-1331, and as follows:

GND Ground zero voltage potential
 V_{IN} Voltage level at an input terminal
 I_{IN} Current flowing into an input terminal

6.6 Logistic support. Lead materials and finishes (see 3.4) are interchangeable. Unless otherwise specified, microcircuits acquired for Government logistic support will be acquired to device class B (see 1.2.2), lead material and finish A (see 3.4). Longer length leads and lead forming should not affect the part number.

6.7 Substitutability. The cross-reference information below is presented for the convenience of users. Microcircuits covered by this specification will functionally replace the listed generic-industry type. Generic-industry microcircuit types may not have equivalent operational performance characteristics across military temperature ranges or reliability factors equivalent to MIL-M-35810 device types and may have slight physical variations in relation to case size. The presence of this information should not be deemed as permitting substitution of generic-industry types for MIL-M-38510 types or as a waiver of any of the provisions of MIL-PRF-38535.

Military device type	Generic-industry type
01	5442
02	5443
03	5444
04	5445
05	54145
06	5446
07	5447
08	5448
09	5449

6.8 Manufacturers' designation. Manufacturers' circuits which form a part of this specification are designated with an "X" as shown in table IV herein.

TABLE IV. Manufacturers' designations.

Device type	Circuit				
	Texas Instruments	Signetics	National Semiconductor/ Fairchild Semiconductor	Motorola Inc.	Fairchild
01	D	C	E	B	A
04	C	A	E	B	D
05	C	A	E	B	D
06	C	B	D		
07	C	B	D		
08	B	C	E	A	

6.9 Changes from previous issue. Marginal notations are not used in this revision to identify changes with respect to the previous issue due to the extensiveness of the changes.

Custodians:

Army - CR
Navy - EC
Air Force - 11
DLA - CC

Preparing activity:
DLA - CC

(Project 5962-2093)

Review activities:

Army - MI, SM
Navy - AS, CG, MC, SH, TD
Air Force - 03, 19, 99

NOTE: The activities listed above were interested in this document as of the date of this document. Since organizations and responsibilities can change, you should verify the currency of the information above using the ASSIST Online database at <http://assist.daps.dla.mil>.